19-4253; Rev 0; 12/08

Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

General Description

The MAX19995 dual-channel downconverter provides 9dB of conversion gain, +24.8dBm input IP3, +13.3dBm 1dB input compression point, and a noise figure as low as 9dB for 1700MHz to 2200MHz diversity receiver applications. With an optimized LO frequency range of 1400MHz to 2000MHz, this mixer is ideal for low-side LO injection architectures. High-side LO injection is supported by the MAX19995A, which is pin-pin and functionally compatible with the MAX19995.

In addition to offering excellent linearity and noise performance, the MAX19995 also yields a high level of component integration. This device includes two double-balanced passive mixer cores, two LO buffers, a dual-input LO selectable switch, and a pair of differential IF output amplifiers. Integrated on-chip baluns allow for single-ended RF and LO inputs.

The MAX19995 requires a nominal LO drive of 0dBm and a typical supply current of 297mA at V_{CC} = 5.0V or 212mA at V_{CC} = 3.3V.

The MAX19995/MAX19995A are pin compatible with the MAX19985/MAX19985A series of 700MHz to 1000MHz mixers and pin similar with the MAX19997A/MAX19999 series of 1800MHz to 4000MHz mixers, making this entire family of downconverters ideal for applications where a common PCB layout is used across multiple frequency bands.

The MAX19995 is available in a 6mm x 6mm, 36-pin thin QFN package with an exposed pad. Electrical performance is guaranteed over the extended temperature range, from T_C = -40°C to +85°C.

Applications

UMTS/WCDMA/LTE Base Stations

cdma2000® Base Stations

DCS1800 and EDGE Base Stations

PCS1900 and EDGE Base Stations

PHS/PAS Base Stations

Fixed Broadband Wireless Access

Wireless Local Loop

Private Mobile Radios

Military Systems

Pin Configuration and Typical Application Circuit appear at end of data sheet.

Features

- **1700MHz to 2200MHz RF Frequency Range**
- **1400MHz to 2000MHz LO Frequency Range**
- **1750MHz to 2700MHz LO Frequency Range (MAX19995A)**
- **50MHz to 500MHz IF Frequency Range**
- **9dB Typical Conversion Gain**
- **9dB Typical Noise Figure**
- **+24.8dBm Typical Input IP3**
- **+13.3dBm Typical Input 1dB Compression Point**
- **79dBc Typical 2RF-2LO Spurious Rejection at P_{RF} = -10dBm**
- **Dual Channels Ideal for Diversity Receiver Applications**
- **49dB Typical Channel-to-Channel Isolation**
- **Low -3dBm to +3dBm LO Drive**
- **Integrated LO Buffer**
- **Internal RF and LO Baluns for Single-Ended Inputs**
- **Built-In SPDT LO Switch with 56dB LO-to-LO Isolation and 50ns Switching Time**
- **Pin Compatible with the MAX19985/MAX19985A/MAX19995A Series of 700MHz to 2200MHz Mixers**
- **Pin Similar to the MAX19997A/MAX19999 Series of 1800MHz to 4000MHz Mixers**
- **Single +5.0V or +3.3V Supply**
- **External Current-Setting Resistors Provide Option for Operating Device in Reduced-Power/Reduced-Performance Mode**

Ordering Information

PART	TEMP RANGE	PIN-PACKAGE
MAX19995ETX+	-40°C to +85°C	36 Thin QFN-EP*
MAX19995ETX+T	-40°C to +85°C	36 Thin QFN-EP*

+Denotes a lead(Pb)-free/RoHS-compliant package.

**EP = Exposed pad.*

T = Tape and reel.

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For pricing, delivery, and ordering information, please contact Maxim Direct at 1-888-629-4642, or visit Maxim's website at www.maxim-ic.com.

Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

ABSOLUTE MAXIMUM RATINGS

V_{CC} to GND .....-0.3V to +5.5V
LO1, LO2 to GND .....±0.3V
Any Other Pins to GND.....-0.3V to (V_{CC} + 0.3V)
RFMAIN, RFDIV, and LO_ Input Power .....+15dBm
RFMAIN, RFDIV Current (RF is DC shorted to GND through a balun).....50mA
Continuous Power Dissipation (Note 1) 8.7W
θ_{JA} (Notes 2, 3).....+38°C/W
θ_{JC} (Notes 1, 3).....7.4°C/W
Operating Case Temperature Range (Note 4).....-40°C to +85°C
Junction Temperature .....+150°C
Storage Temperature Range .....-65°C to +150°C
Lead Temperature (soldering, 10s) .....+300°C

Note 1: Based on junction temperature $T_J = T_C + (\theta_{JC} \times V_{CC} \times I_{CC})$. This formula can be used when the temperature of the exposed pad is known while the device is soldered down to a PCB. See the *Applications Information* section for details. The junction temperature must not exceed +150°C.

Note 2: Junction temperature $T_J = T_A + (\theta_{JA} \times V_{CC} \times I_{CC})$. This formula can be used when the ambient temperature of the PCB is known. The junction temperature must not exceed +150°C.

Note 3: Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a four-layer board. For detailed information on package thermal considerations, refer to **www.maxim-ic.com/thermal-tutorial.**

Note 4: T_C is the temperature on the exposed pad of the package. T_A is the ambient temperature of the device and PCB.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

+5.0V SUPPLY DC ELECTRICAL CHARACTERISTICS

(*Typical Application Circuit* optimized for the DCS/PCS band, V_{CC} = +4.75V to +5.25V, T_C = -40°C to +85°C. R1 = R4 = 806Ω, R2 = R5 = 2.32kΩ. Typical values are at V_{CC} = +5.0V, T_C = +25°C, unless otherwise noted. All parameters are production tested.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Supply Voltage	V_{CC}		4.75	5	5.25	V
Supply Current	I_{CC}	Total supply current, V_{CC} = +5.0V		297	370	mA
LOSEL Input High Voltage	V_{IH}		2			V
LOSEL Input Low Voltage	V_{IL}				0.8	V
LOSEL Input Current	I_{IH} and I_{IL}		-10		+10	µA

+3.3V SUPPLY DC ELECTRICAL CHARACTERISTICS

(*Typical Application Circuit*, V_{CC} = +3.0V to +3.6V, T_C = -40°C to +85°C, R1 = R4 = 909Ω, R2 = R5 = 2.49kΩ. Typical values are at V_{CC} = +3.3V, T_C = +25°C, unless otherwise noted. All parameters are guaranteed by design and not production tested.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Supply Voltage	V_{CC}		3.0	3.3	3.6	V
Supply Current	I_{CC}	Total supply current, V_{CC} = +3.3V		212		mA
LOSEL Input High Voltage	V_{IH}			2		V
LOSEL Input Low Voltage	V_{IL}			0.8		V

RECOMMENDED AC OPERATING CONDITIONS

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
RF Frequency	f_{RF}	(Note 5)	1700		2200	MHz
LO Frequency	f_{LO}	(Note 5)	1400		2000	MHz
IF Frequency	f_{IF}	Using Mini-Circuits TC4-1W-17 4:1 transformer as defined in the typical application circuit, IF matching components affect the IF frequency range (Note 5)	100		500	MHz
		Using alternative Mini-Circuits TC4-1W-7A 4:1 transformer, IF matching components affect the IF frequency range (Note 5)	50		250	MHz
LO Drive Level	P_{LO}		-3		+3	dBm

+5.0V SUPPLY AC ELECTRICAL CHARACTERISTICS

(*Typical Application Circuit* optimized for the DCS/PCS band, R1 = R4 = 806Ω, R2 = R5 = 2.32kΩ, V_{CC} = +4.75V to +5.25V, RF and LO ports are driven from 50Ω sources, P_{LO} = -3dBm to +3dBm, P_{RF} = -5dBm, f_{RF} = 1700MHz to 2000MHz, f_{LO} = 1510MHz to 1810MHz, f_{IF} = 190MHz, $f_{RF} > f_{LO}$, T_C = -40°C to +85°C. Typical values are at V_{CC} = +5.0V, P_{RF} = -5dBm, P_{LO} = 0dBm, f_{RF} = 1800MHz, f_{LO} = 1610MHz, f_{IF} = 190MHz, T_C = +25°C, unless otherwise noted.) (Note 6)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Conversion Gain	G_C		7	9	11	dB
		T_C = +25°C	7.8	9	10.2	
		Typical Application Circuit optimized for UMTS band (R1 = R4 = 681Ω, R2 = R5 = 1.5kΩ), f_{LO} = 1760MHz, f_{RF} = 1950MHz		8.9		
Conversion Gain Flatness		Flatness over any one of three frequency bands: f_{RF} = 1710MHz to 1785MHz f_{RF} = 1850MHz to 1910MHz f_{RF} = 1920MHz to 1980MHz		±0.1		dB
Gain Variation Over Temperature	TC_{CG}	f_{RF} = 1700MHz to 2000MHz, f_{LO} = 1510MHz to 1810MHz, f_{IF} = 190MHz, T_C = -40°C to +85°C		-0.009		dB/°C
Input Compression Point (Note 7)	IP_{1dB}	f_{RF} = 1700MHz for min value	9.5	12.5		dBm
		Typical Application Circuit optimized for UMTS band (R1 = R4 = 681Ω, R2 = R5 = 1.5kΩ), f_{LO} = 1760MHz, f_{IF} = 190MHz, f_{RF} = 1950MHz		13.3		

Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

+5.0V SUPPLY AC ELECTRICAL CHARACTERISTICS (continued)

(*Typical Application Circuit* optimized for the DCS/PCS band, R1 = R4 = 806Ω, R2 = R5 = 2.32kΩ, V_{CC} = +4.75V to +5.25V, RF and LO ports are driven from 50Ω sources, P_{LO} = -3dBm to +3dBm, P_{RF} = -5dBm, f_{RF} = 1700MHz to 2000MHz, f_{LO} = 1510MHz to 1810MHz, f_{IF} = 190MHz, $f_{RF} > f_{LO}$, T_C = -40°C to +85°C. Typical values are at V_{CC} = +5.0V, P_{RF} = -5dBm, P_{LO} = 0dBm, f_{RF} = 1800MHz, f_{LO} = 1610MHz, f_{IF} = 190MHz, T_C = +25°C, unless otherwise noted.) (Note 6)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Input Intercept Point	IIP3	f_{RF1} - f_{RF2} = 1MHz, P_{RF} = -5dBm per tone, f_{RF} = 2000MHz for min value	20.5	23.7		dBm
		f_{IF} = 190MHz, f_{LO} = 1810MHz, f_{RF} = 2000MHz for min value, f_{RF1} - f_{RF2} = 1MHz, P_{RF} = -5dBm per tone, T_C = +25°C to +85°C	21.5	23.7		
		Typical Application Circuit optimized for UMTS band (R1 = R4 = 681Ω, R2 = R5 = 1.5kΩ), f_{LO} = 1760MHz, f_{IF} = 190MHz, f_{RF} = 1950MHz, f_{RF1} - f_{RF2} = 1MHz, P_{RF} = -5dBm per tone		24.8		
Input Intercept Variation Over Temperature	TC_{IIP3}	f_{RF1} - f_{RF2} = 1MHz, P_{RF} = -5dBm per tone, T_C = -40°C to +85°C		0.0035		dBm/°C
Noise Figure	NF_{SSB}	Single sideband, no blockers present (Note 8)		9	11	dB
		f_{LO} = 1610MHz, f_{IF} = 190MHz, f_{RF} = 1800MHz, T_C = +25°C, P_{LO} = 0dBm, single sideband, no blockers present (Note 8)		9	9.6	
		Typical Application Circuit optimized for UMTS band (R1 = R4 = 681Ω , R2 = R5 = 1.5kΩ), f_{IF} = 190MHz, f_{LO} = 1760MHz, f_{RF} = 1950MHz, single sideband, no blockers present		9.3		
Noise Figure Temperature Coefficient	TC_{NF}	Single sideband, no blockers present, T_C = -40°C to +85°C		0.016		dB/°C
Noise Figure with Blocker	NF_B	$f_{BLOCKER}$ = 1900MHz, $P_{BLOCKER}$ = +8dBm, f_{RF} = 1800MHz, f_{LO} = 1610MHz, P_{LO} = 0dBm, V_{CC} = +5.0V, T_C = +25°C (Notes 8, 9)		19	20.5	dB

+5.0V SUPPLY AC ELECTRICAL CHARACTERISTICS (continued)

(*Typical Application Circuit* optimized for the DCS/PCS band, R1 = R4 = 806Ω, R2 = R5 = 2.32kΩ, V_{CC} = +4.75V to +5.25V, RF and LO ports are driven from 50Ω sources, P_{LO} = -3dBm to +3dBm, P_{RF} = -5dBm, f_{RF} = 1700MHz to 2000MHz, f_{LO} = 1510MHz to 1810MHz, f_{IF} = 190MHz, $f_{RF} > f_{LO}$, T_C = -40°C to +85°C. Typical values are at V_{CC} = +5.0V, P_{RF} = -5dBm, P_{LO} = 0dBm, f_{RF} = 1800MHz, f_{LO} = 1610MHz, f_{IF} = 190MHz, T_C = +25°C, unless otherwise noted.) (Note 6)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
2RF-2LO Spur Rejection	2 x 2	f_{RF} = 1800MHz, f_{LO} = 1610MHz, P_{RF} = -10dBm (Note 8)	54	79		dBc
		f_{RF} = 1800MHz, f_{LO} = 1610MHz, P_{RF} = -5dBm (Note 8)	49	74		
		f_{RF} = 1800MHz, f_{LO} = 1610MHz, P_{LO} = 0dBm, P_{RF} = -10dBm, V_{CC} = +5.0V, T_C = +25°C (Note 8)	56	79		
		f_{RF} = 1800MHz, f_{LO} = 1610MHz, P_{LO} = 0dBm, P_{RF} = -5dBm, V_{CC} = +5.0V, T_C = +25°C (Note 8)	51	74		
		Typical Application Circuit optimized for UMTS band (R1 = R4 = 681Ω, R2 = R5 = 1.5kΩ), f_{IF} = 190MHz, f_{LO} = 1760MHz, f_{RF} = 1950MHz, P_{RF} = -10dBm		79		
		Typical Application Circuit optimized for UMTS band (R1 = R4 = 681Ω, R2 = R5 = 1.5kΩ), f_{IF} = 190MHz, f_{LO} = 1760MHz, f_{RF} = 1950MHz, P_{RF} = -5dBm		74		
3RF-3LO Spur Rejection	3 x 3	f_{RF} = 1800MHz, f_{LO} = 1610MHz, P_{RF} = -10dBm (Note 8)	77	91		dBc
		f_{RF} = 1800MHz, f_{LO} = 1610MHz, P_{RF} = -5dBm (Note 8)	67	81		
		f_{RF} = 1800MHz, f_{LO} = 1610MHz, P_{LO} = 0dBm, P_{RF} = -10dBm, V_{CC} = +5.0V, T_C = +25°C (Note 8)	79	91		
		f_{RF} = 1800MHz, f_{LO} = 1600MHz, P_{LO} = 0dBm, P_{RF} = -5dBm, V_{CC} = +5.0V, T_C = +25°C (Note 8)	69	81		
		Typical Application Circuit optimized for UMTS band (R1 = R4 = 681Ω, R2 = R5 = 1.5kΩ), f_{IF} = 190MHz, f_{LO} = 1760MHz, f_{RF} = 1950MHz, P_{RF} = -10dBm		86		
		Typical Application Circuit optimized for UMTS band (R1 = R4 = 681Ω, R2 = R5 = 1.5kΩ), f_{IF} = 190MHz, f_{LO} = 1760MHz, f_{RF} = 1950MHz, P_{RF} = -5dBm		76		

Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

+5.0V SUPPLY AC ELECTRICAL CHARACTERISTICS (continued)

(*Typical Application Circuit* optimized for the DCS/PCS band, R1 = R4 = 806Ω, R2 = R5 = 2.32kΩ, V_{CC} = +4.75V to +5.25V, RF and LO ports are driven from 50Ω sources, P_{LO} = -3dBm to +3dBm, P_{RF} = -5dBm, f_{RF} = 1700MHz to 2000MHz, f_{LO} = 1510MHz to 1810MHz, f_{IF} = 190MHz, $f_{RF} > f_{LO}$, T_C = -40°C to +85°C. Typical values are at V_{CC} = +5.0V, P_{RF} = -5dBm, P_{LO} = 0dBm, f_{RF} = 1800MHz, f_{LO} = 1610MHz, f_{IF} = 190MHz, T_C = +25°C, unless otherwise noted.) (Note 6)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
RF Input Return Loss		LO and IF terminated into matched impedance, LO on		21		dB
LO Input Return Loss		LO port selected, RF and IF terminated into matched impedance		20		dB
		LO port unselected, RF and IF terminated into matched impedance		19		
IF Output Impedance	Z_{IF}	Nominal differential impedance of the IC's IF outputs		200		Ω
IF Return Loss		RF terminated into 50Ω, LO driven by 50Ω source, IF transformed to 50Ω using external components shown in *Typical Application Circuit*		12.5		dB
RF-to-IF Isolation		f_{RF} = 1700MHz for min value	30	39		dB
LO Leakage at RF Port		(Notes 8, 10)		-31	-24.7	dBm
2LO Leakage at RF Port		(Note 8)		-20	-16	dBm
LO Leakage at IF Port		(Note 8)		-40	-27	dBm
Channel Isolation		RFMAIN converted power measured at IFD_, relative to IFM_, all unused ports terminated to 50Ω	40	49		dB
		RFDIV converted power measured at IFM_, relative to IFD_, all unused ports terminated to 50Ω	40	49		
LO-to-LO Isolation		P_{LO1} = +3dBm, P_{LO2} = +3dBm, f_{LO1} = 1610MHz, f_{LO2} = 1611MHz	40	56		dB
LO Switching Time		50% of LOSEL to IF settled within 2 degrees		50		ns

+3.3V SUPPLY AC ELECTRICAL CHARACTERISTICS

(*Typical Application Circuit*. Typical values are at V_{CC} = +3.3V, P_{RF} = -5dBm, P_{LO} = 0dBm, f_{RF} = 1800MHz, f_{LO} = 1610MHz, f_{IF} = 190MHz, T_C = +25°C, unless otherwise noted.) (Note 6)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Conversion Gain	G_C			8.4		dB
Conversion Gain Flatness		Flatness over any one of three frequency bands: f_{RF} = 1710MHz to 1785MHz f_{RF} = 1850MHz to 1910MHz f_{RF} = 1920MHz to 1980MHz		±0.1		dB
Gain Variation Over Temperature	TC_{CG}	T_C = -40°C to +85°C		-0.009		dB/°C

+3.3V SUPPLY AC ELECTRICAL CHARACTERISTICS (continued)

(*Typical Application Circuit*. Typical values are at V_{CC} = +3.3V, P_{RF} = -5dBm, P_{LO} = 0dBm, f_{RF} = 1800MHz, f_{LO} = 1610MHz, f_{IF} = 190MHz, T_C = +25°C, unless otherwise noted.) (Note 6)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Input Compression Point	IP_{1dB}	(Note 7)		8.9		dBm
Input Intercept Point	IIP3	f_{RF1} - f_{RF2} = 1MHz		18.5		dBm
Input Intercept Variation Over Temperature	TC_{IIP3}	f_{RF1} - f_{RF2} = 1MHz, T_C = -40°C to +85°C		0.0034		dBm/°C
Noise Figure	NF_{SSB}	Single sideband, no blockers present		9.0		dB
Noise Figure Temperature Coefficient	TC_{NF}	Single sideband, no blockers present, T_C = -40°C to +85°C		0.016		dB/°C
2RF-2LO Spur Rejection	2 x 2	P_{RF} = -10dBm		73		dBc
		P_{RF} = -5dBm		68		
3RF-3LO Spur Rejection	3 x 3	P_{RF} = -10dBm		70		dBc
		P_{RF} = -5dBm		60		
RF Input Return Loss		LO on and IF terminated		21		dB
LO Input Return Loss		LO port selected, RF and IF terminated into matched impedance		16		dB
		LO port unselected, RF and IF terminated into matched impedance		20		
IF Return Loss		RF terminated into 50Ω, LO driven by 50Ω source, IF transformed to 50Ω using external components shown in *Typical Application Circuit*, f_{IF} = 190MHz		12.5		dB
RF-to-IF Isolation				42		dB
LO Leakage at RF Port				-40		dBm
2LO Leakage at RF Port				-29		dBm
LO Leakage at IF Port				-43		dBm
Channel Isolation		RFMAIN converted power measured at IFD_, relative to IFM_, all unused ports terminated to 50Ω		49		dB
		RFDIV converted power measured at IFM_, relative to IFD_, all unused ports terminated to 50Ω		49		
LO-to-LO Isolation		P_{LO1} = +3dBm, P_{LO2} = +3dBm, f_{LO1} = 1610MHz, f_{LO2} = 1611MHz		55		dB
LO Switching Time		50% of LOSEL to IF settled within 2 degrees		50		ns

Note 5: Not production tested. Operation outside this range is possible, but with degraded performance of some parameters. See the *Typical Operating Characteristics*.

Note 6: All limits reflect losses of external components, including a 0.65dB loss at f_{IF} = 190MHz due to the 4:1 impedance transformer. Output measurements were taken at IF outputs of the *Typical Application Circuit*.

Note 7: Maximum reliable continuous input power applied to the RF or IF port of this device is +12dBm from a 50Ω source.

Note 8: Guaranteed by design and characterization.

Note 9: Measured with external LO source noise filtered so the noise floor is -174dBm/Hz. This specification reflects the effects of all SNR degradations in the mixer, including the LO noise as defined in Application Note 2021: *Specifications and Measurement of Local Oscillator Noise in Integrated Circuit Base Station Mixers.*

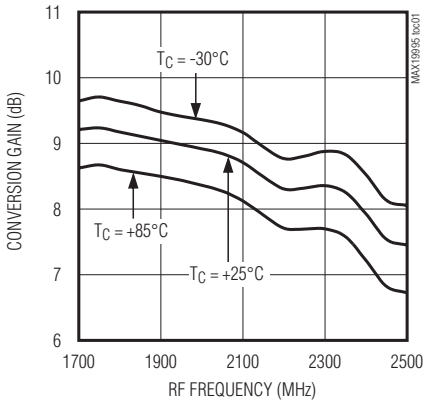
Note 10: Limited production testing.

Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

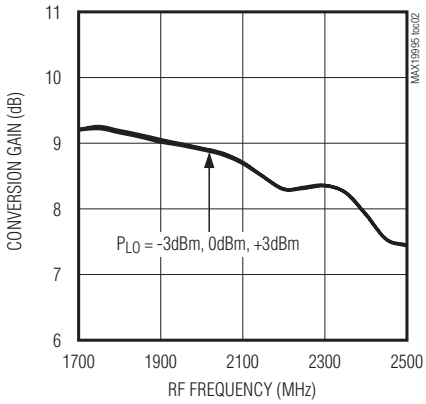
Typical Operating Characteristics

(*Typical Application Circuit*, optimized for the **DCS/PCS band**, **R1 = R4 = 806Ω**, **R2 = R5 = 2.32kΩ**, **V_{CC} = +5.0V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

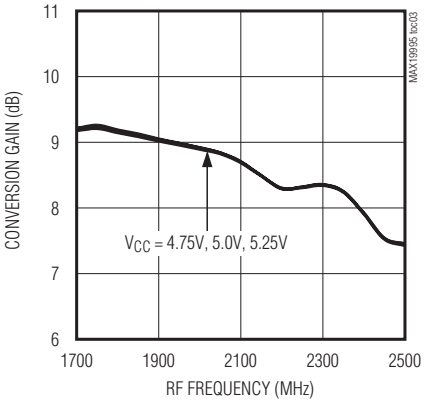
CONVERSION GAIN vs. RF FREQUENCY



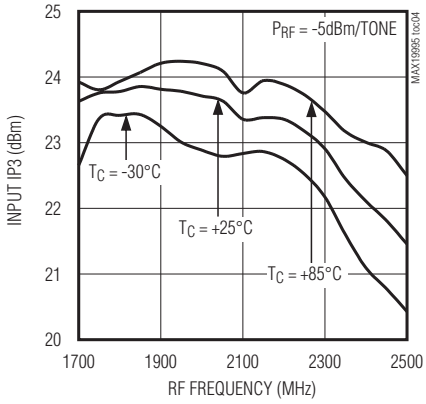
CONVERSION GAIN vs. RF FREQUENCY



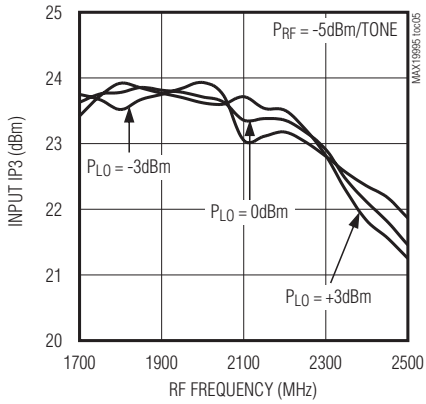
CONVERSION GAIN vs. RF FREQUENCY



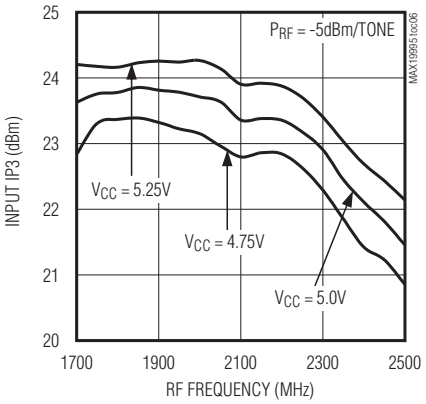
INPUT IP3 vs. RF FREQUENCY



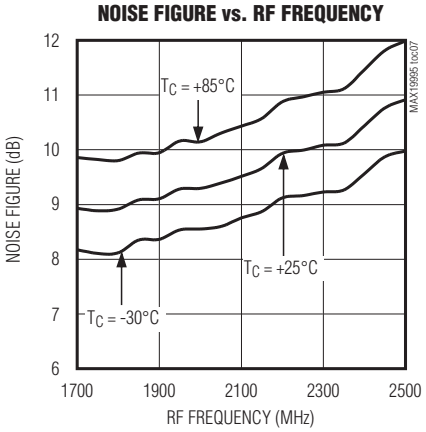
INPUT IP3 vs. RF FREQUENCY



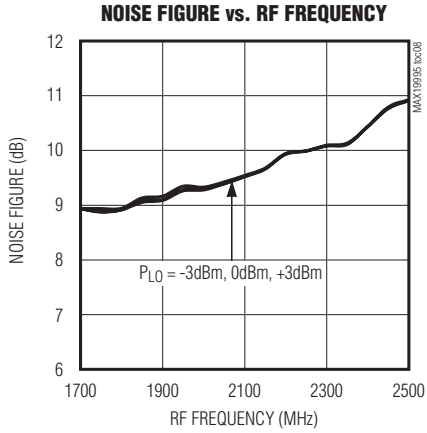
INPUT IP3 vs. RF FREQUENCY



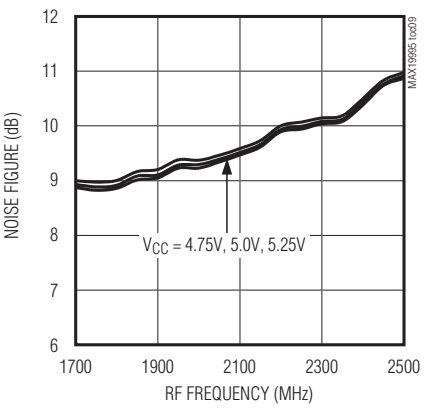
NOISE FIGURE vs. RF FREQUENCY



NOISE FIGURE vs. RF FREQUENCY



NOISE FIGURE vs. RF FREQUENCY

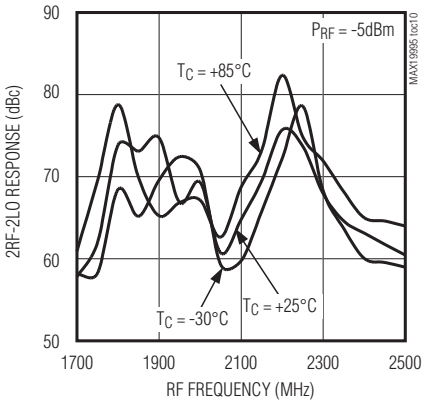


Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

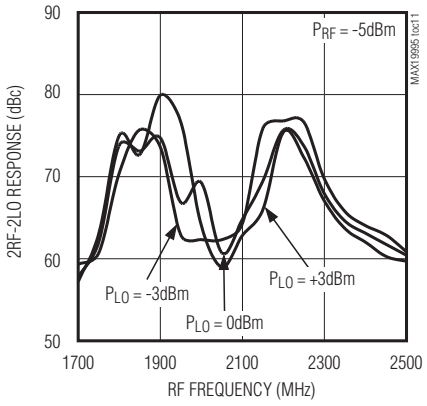
Typical Operating Characteristics (continued)

(*Typical Application Circuit*, optimized for the **DCS/PCS band**, **R1 = R4 = 806Ω**, **R2 = R5 = 2.32kΩ**, **V_{CC} = +5.0V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

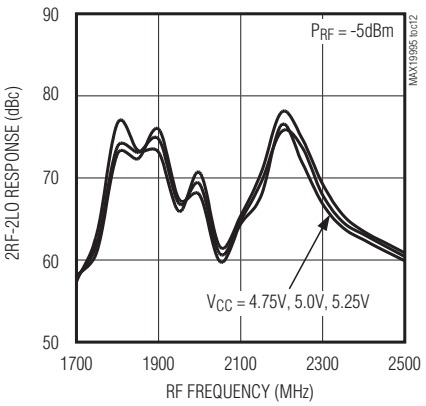
2RF-2LO RESPONSE vs. RF FREQUENCY



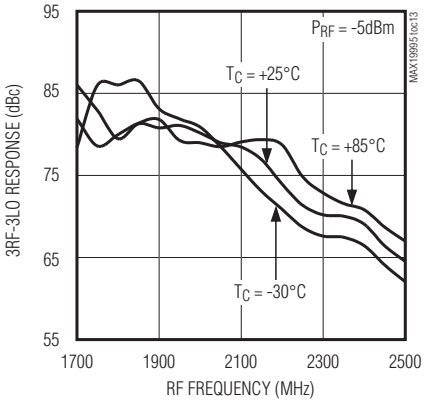
2RF-2LO RESPONSE vs. RF FREQUENCY



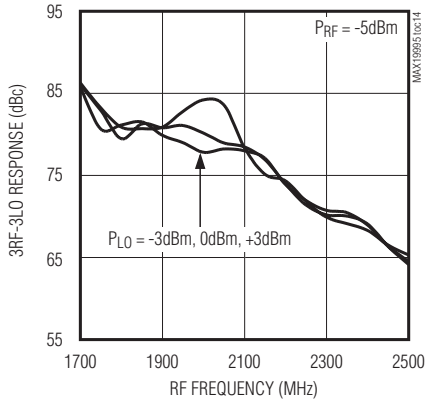
2RF-2LO RESPONSE vs. RF FREQUENCY



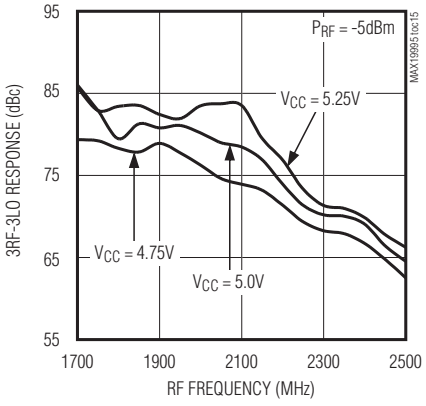
3RF-3LO RESPONSE vs. RF FREQUENCY



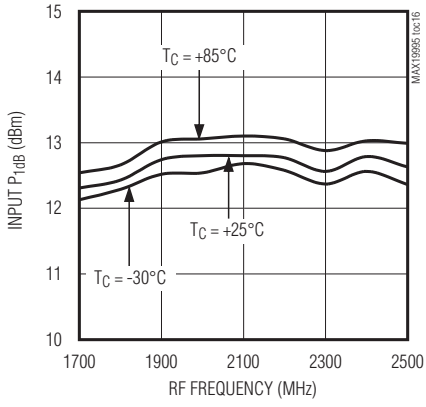
3RF-3LO RESPONSE vs. RF FREQUENCY



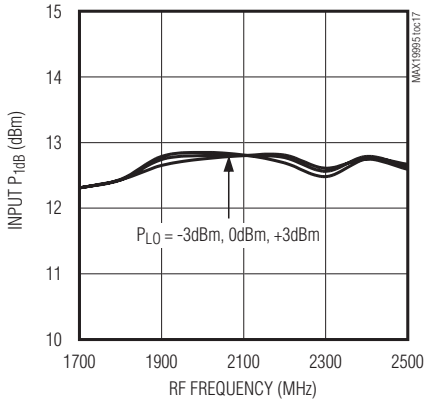
3RF-3LO RESPONSE vs. RF FREQUENCY



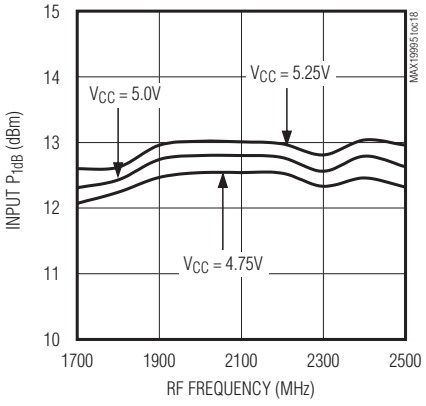
INPUT P_{1dB} vs. RF FREQUENCY



INPUT P_{1dB} vs. RF FREQUENCY



INPUT P_{1dB} vs. RF FREQUENCY

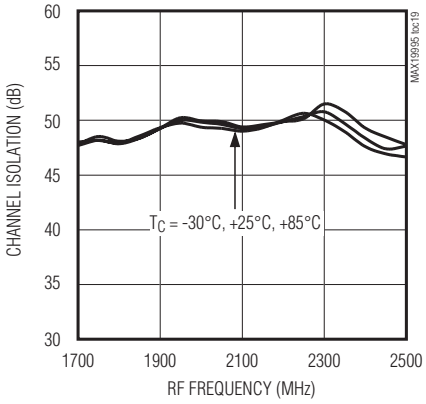


Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

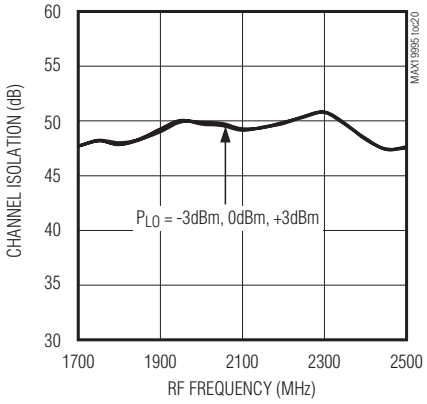
Typical Operating Characteristics (continued)

(*Typical Application Circuit*, optimized for the **DCS/PCS band**, **R1 = R4 = 806Ω**, **R2 = R5 = 2.32kΩ**, **V_{CC} = +5.0V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

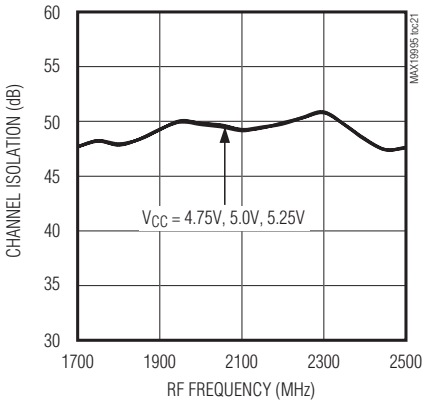
CHANNEL ISOLATION vs. RF FREQUENCY



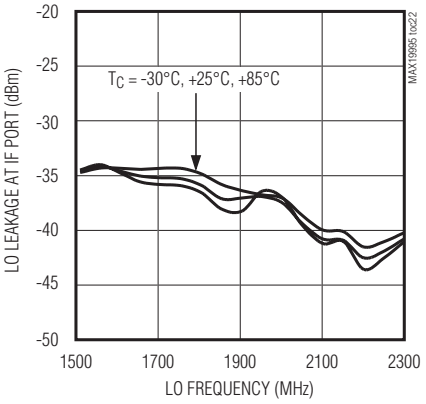
CHANNEL ISOLATION vs. RF FREQUENCY



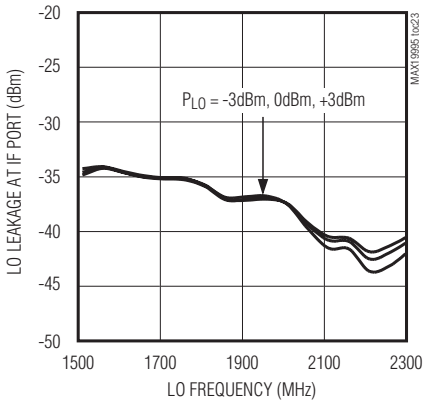
CHANNEL ISOLATION vs. RF FREQUENCY



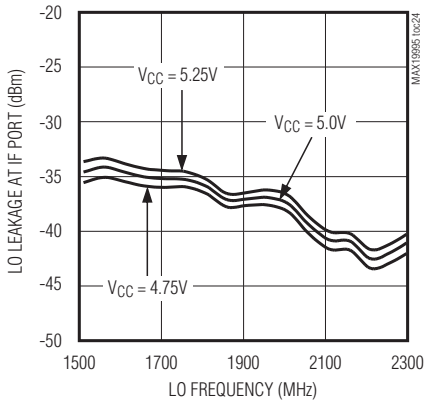
LO LEAKAGE AT IF PORT vs. LO FREQUENCY



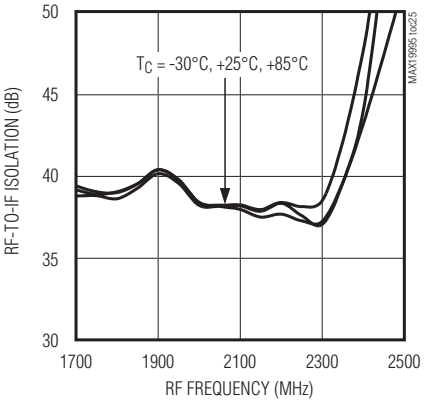
LO LEAKAGE AT IF PORT vs. LO FREQUENCY



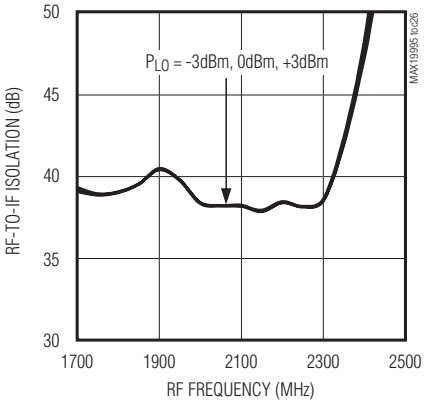
LO LEAKAGE AT IF PORT vs. LO FREQUENCY



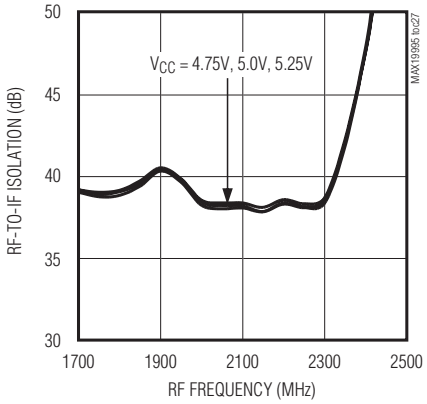
RF-TO-IF ISOLATION vs. RF FREQUENCY



RF-TO-IF ISOLATION vs. RF FREQUENCY



RF-TO-IF ISOLATION vs. RF FREQUENCY

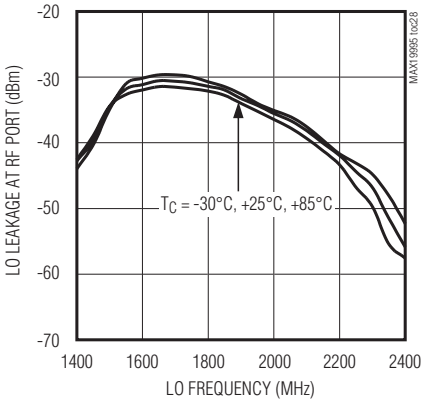


Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

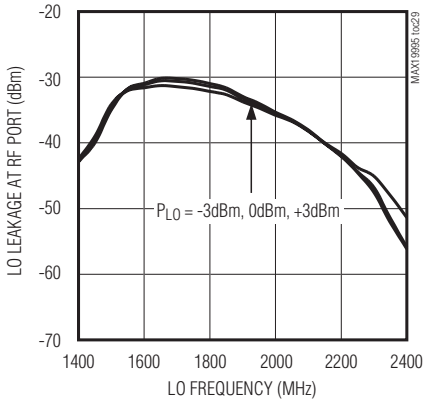
Typical Operating Characteristics (continued)

(*Typical Application Circuit*, optimized for the **DCS/PCS band**, **R1 = R4 = 806Ω**, **R2 = R5 = 2.32kΩ**, **VCC = +5.0V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

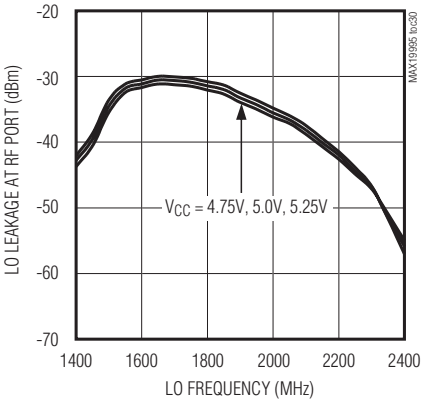
LO LEAKAGE AT RF PORT vs. LO FREQUENCY



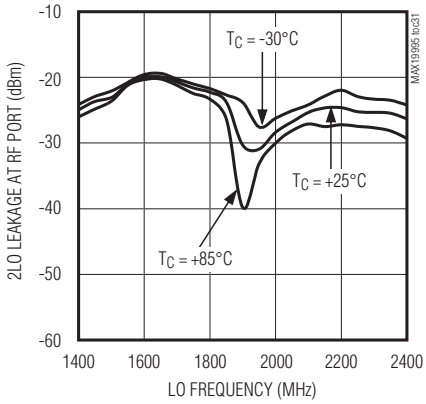
LO LEAKAGE AT RF PORT vs. LO FREQUENCY



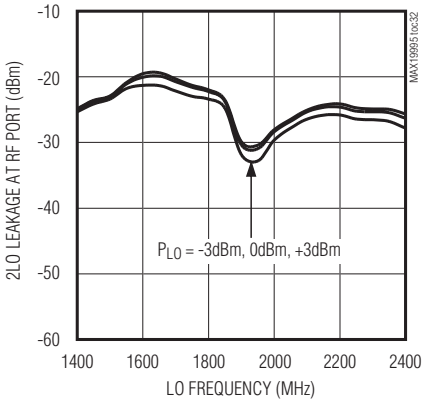
LO LEAKAGE AT RF PORT vs. LO FREQUENCY



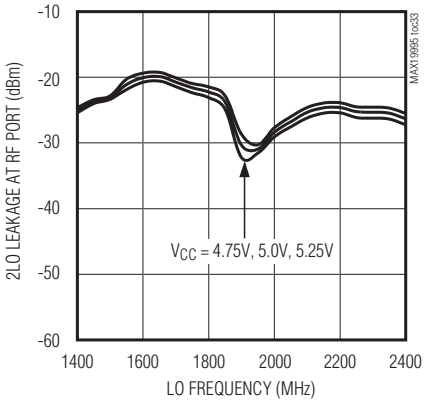
2LO LEAKAGE AT RF PORT vs. LO FREQUENCY



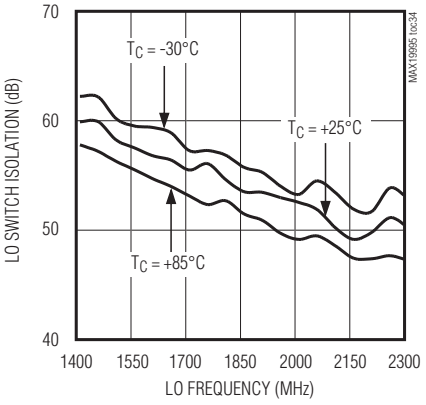
2LO LEAKAGE AT RF PORT vs. LO FREQUENCY



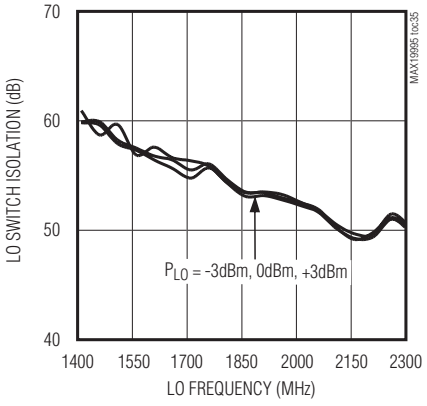
2LO LEAKAGE AT RF PORT vs. LO FREQUENCY



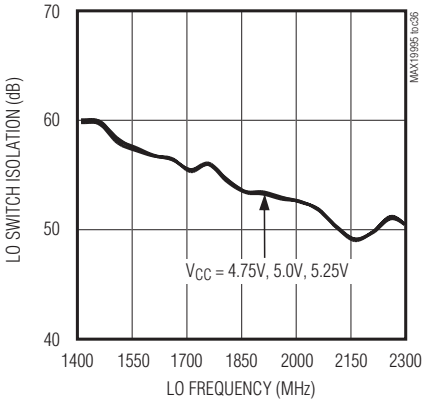
LO SWITCH ISOLATION vs. LO FREQUENCY



LO SWITCH ISOLATION vs. LO FREQUENCY



LO SWITCH ISOLATION vs. LO FREQUENCY

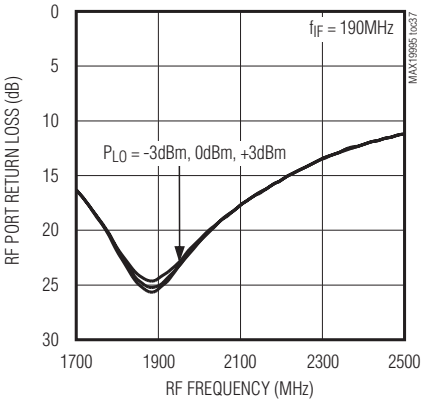


Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

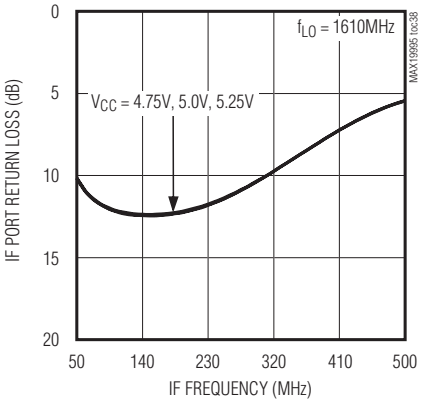
Typical Operating Characteristics (continued)

(*Typical Application Circuit*, optimized for the **DCS/PCS band**, **R1 = R4 = 806Ω**, **R2 = R5 = 2.32kΩ**, **V_{CC} = +5.0V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

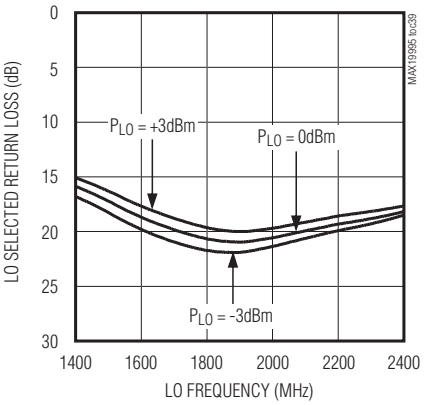
RF PORT RETURN LOSS vs. RF FREQUENCY



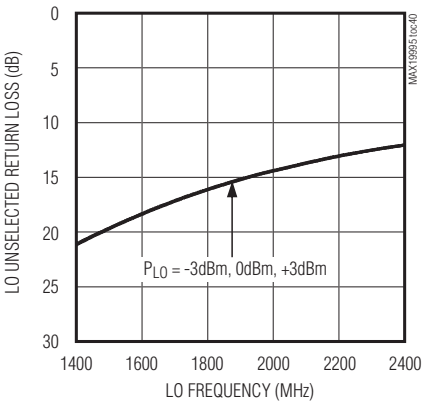
IF PORT RETURN LOSS vs. IF FREQUENCY



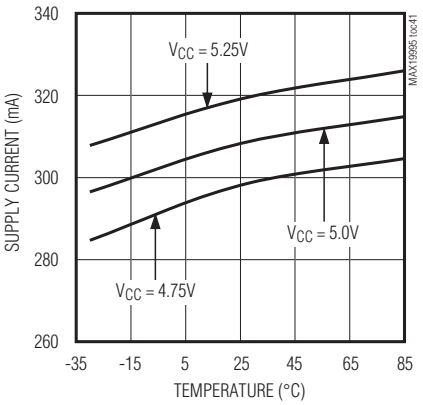
LO SELECTED RETURN LOSS vs. LO FREQUENCY



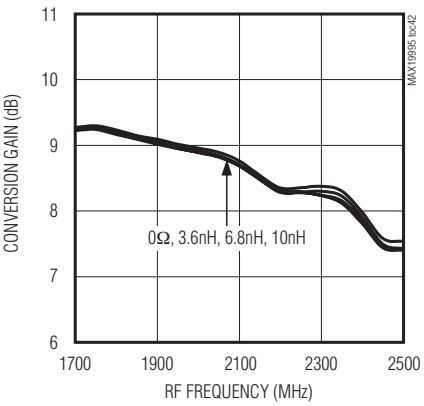
LO UNSELECTED RETURN LOSS vs. LO FREQUENCY



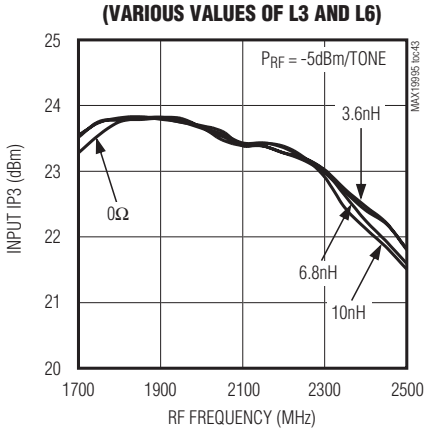
SUPPLY CURRENT vs. TEMPERATURE (T_C)



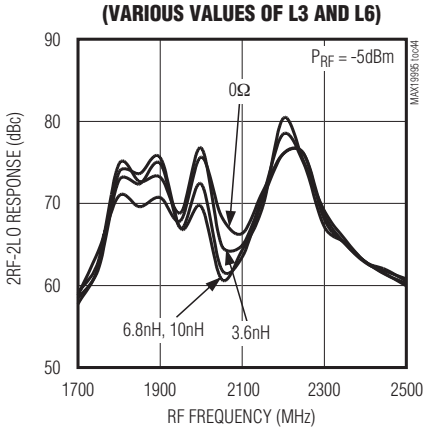
CONVERSION GAIN vs. RF FREQUENCY (VARIOUS VALUES OF L3 AND L6)



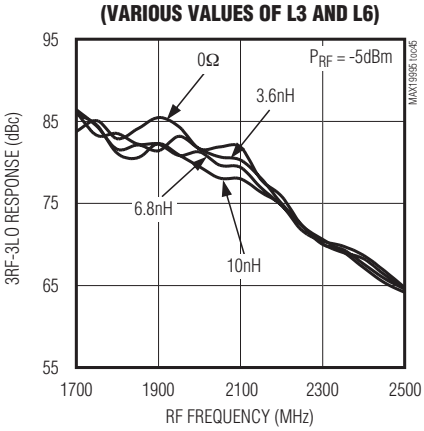
INPUT IP3 vs. RF FREQUENCY (VARIOUS VALUES OF L3 AND L6)



2RF-2LO RESPONSE vs. RF FREQUENCY (VARIOUS VALUES OF L3 AND L6)



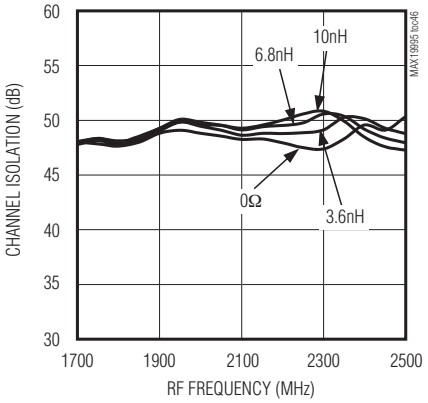
3RF-3LO RESPONSE vs. RF FREQUENCY (VARIOUS VALUES OF L3 AND L6)



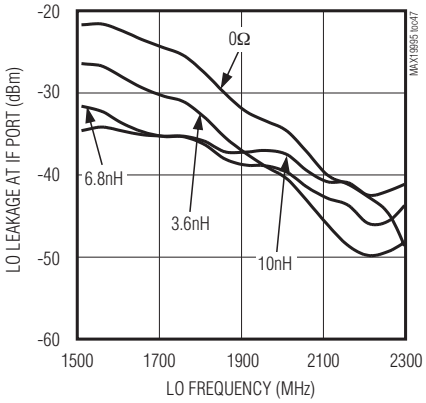
Typical Operating Characteristics (continued)

(*Typical Application Circuit*, optimized for the **DCS/PCS band**, **R1 = R4 = 806Ω**, **R2 = R5 = 2.32kΩ**, **V_{CC} = +5.0V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

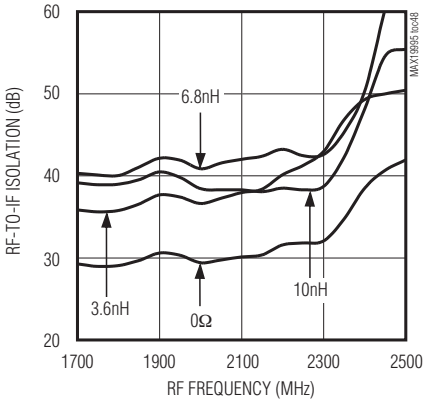
CHANNEL ISOLATION vs. RF FREQUENCY (VARIOUS VALUES OF L3 AND L6)



LO LEAKAGE AT IF PORT vs. LO FREQUENCY (VARIOUS VALUES OF L3 AND L6)



RF-TO-IF ISOLATION vs. RF FREQUENCY (VARIOUS VALUES OF L3 AND L6)

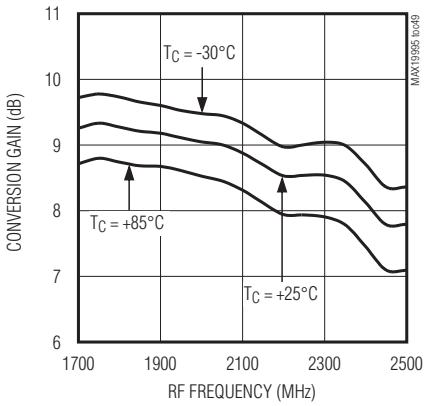


Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

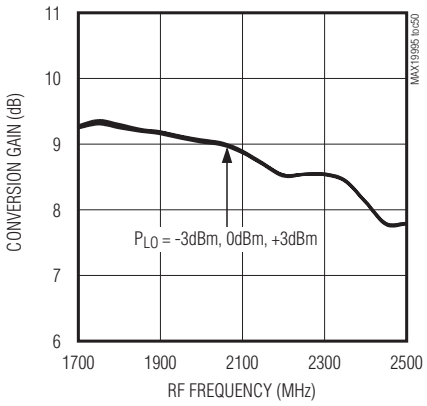
Typical Operating Characteristics (continued)

(*Typical Application Circuit*, optimized for the **UMTS band**, **R1 = R4 = 681Ω, R2 = R5 = 1.5kΩ**, **VCC = +5.0V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

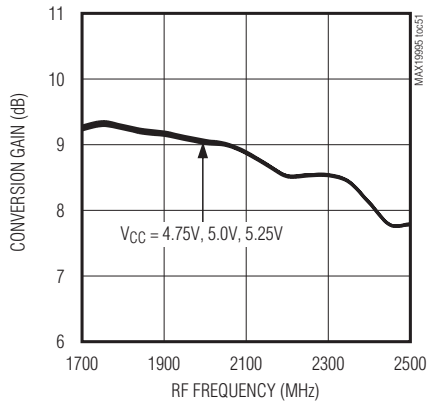
CONVERSION GAIN vs. RF FREQUENCY



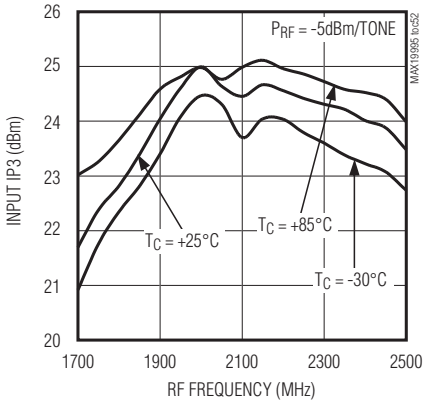
CONVERSION GAIN vs. RF FREQUENCY



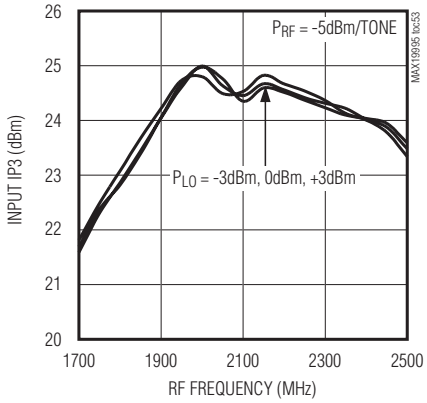
CONVERSION GAIN vs. RF FREQUENCY



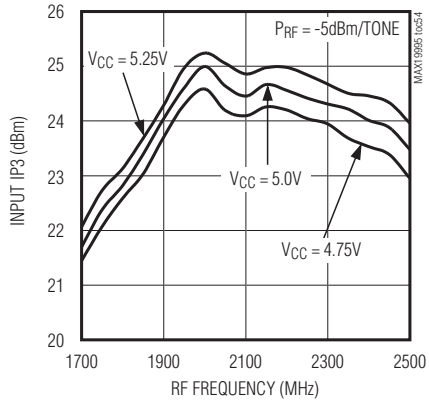
INPUT IP3 vs. RF FREQUENCY



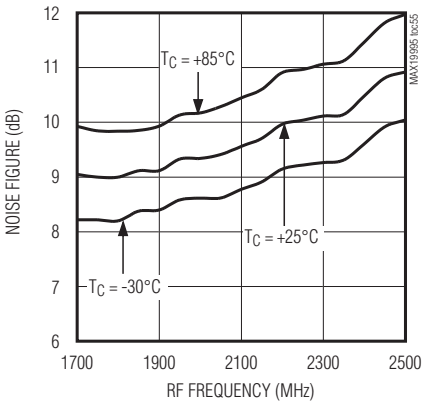
INPUT IP3 vs. RF FREQUENCY



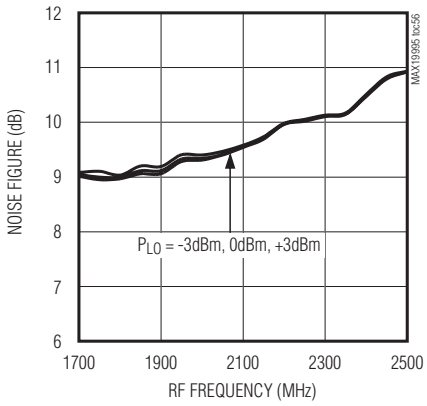
INPUT IP3 vs. RF FREQUENCY



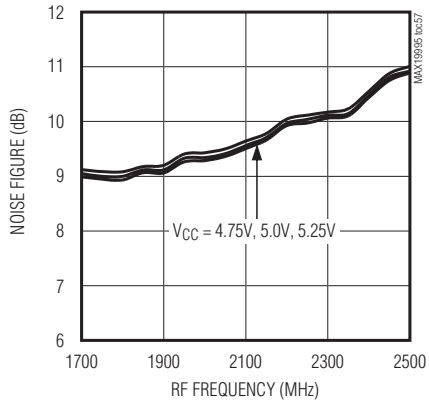
NOISE FIGURE vs. RF FREQUENCY



NOISE FIGURE vs. RF FREQUENCY



NOISE FIGURE vs. RF FREQUENCY

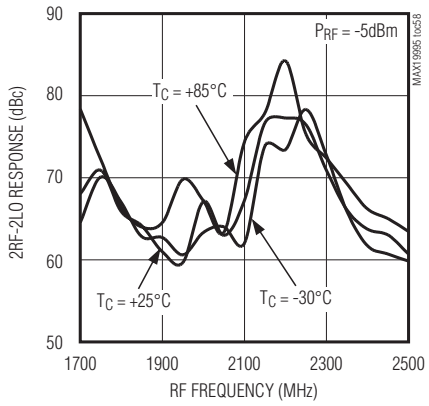


Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

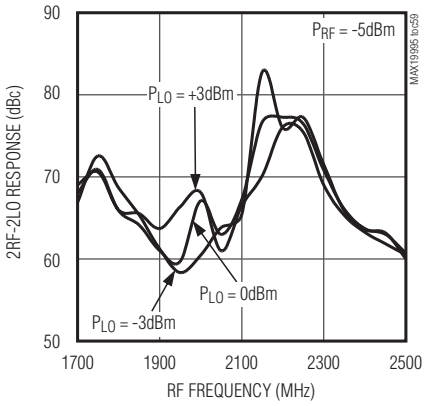
Typical Operating Characteristics (continued)

(*Typical Application Circuit*, optimized for the **UMTS band**, **R1 = R4 = 681Ω, R2 = R5 = 1.5kΩ**, **VCC = +5.0V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

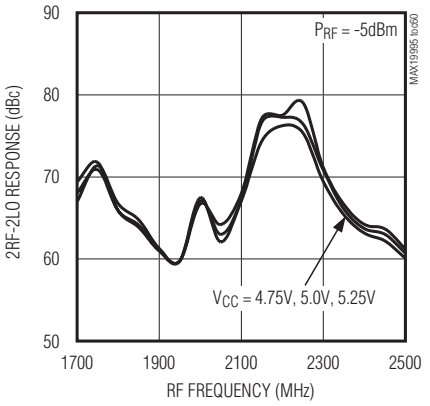
2RF-2LO RESPONSE vs. RF FREQUENCY



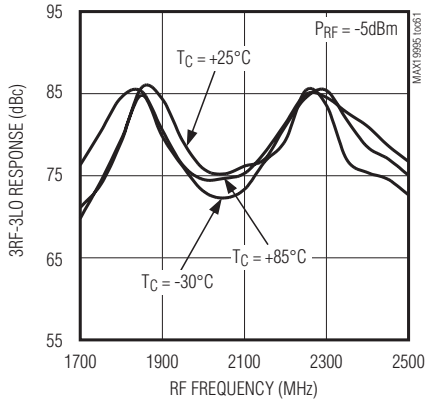
2RF-2LO RESPONSE vs. RF FREQUENCY



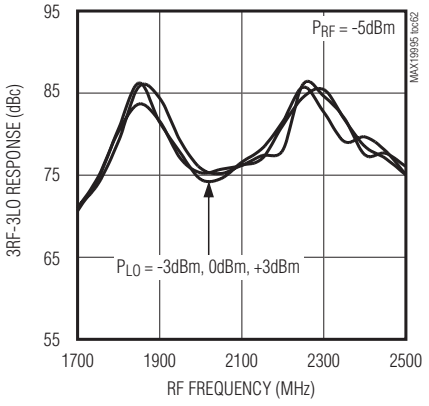
2RF-2LO RESPONSE vs. RF FREQUENCY



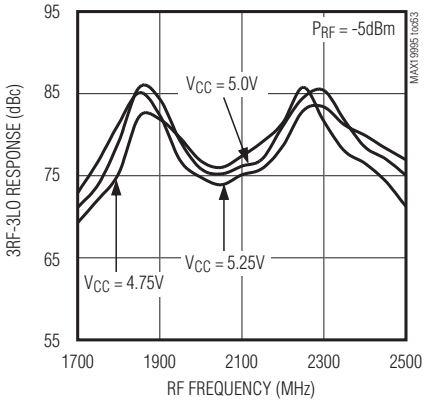
3RF-3LO RESPONSE vs. RF FREQUENCY



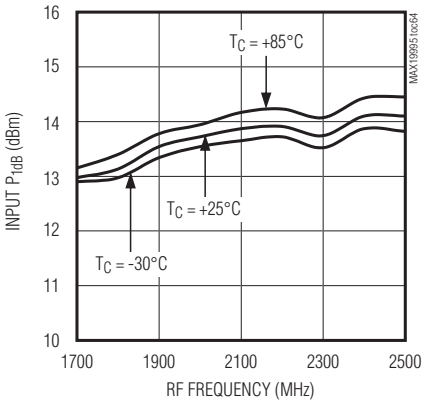
3RF-3LO RESPONSE vs. RF FREQUENCY



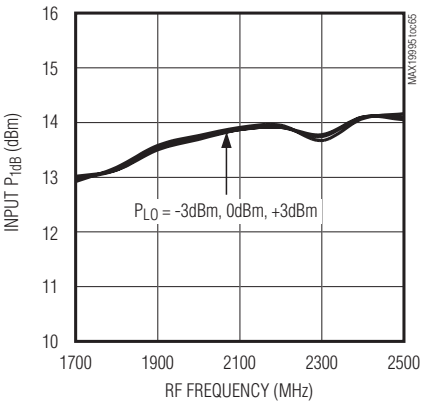
3RF-3LO RESPONSE vs. RF FREQUENCY



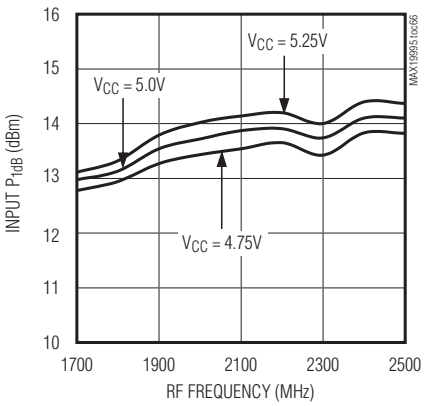
INPUT P_{1dB} vs. RF FREQUENCY



INPUT P_{1dB} vs. RF FREQUENCY



INPUT P_{1dB} vs. RF FREQUENCY

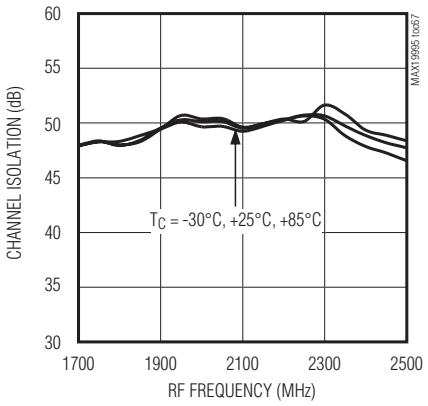


Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

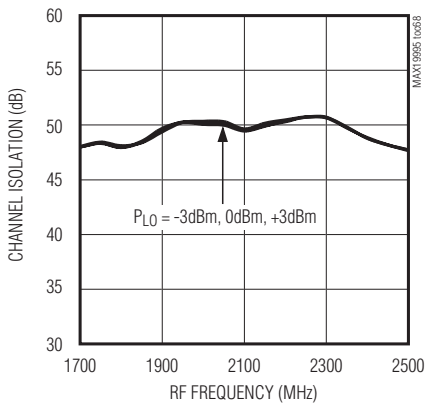
Typical Operating Characteristics (continued)

(*Typical Application Circuit*, optimized for the **UMTS band**, **R1 = R4 = 681Ω, R2 = R5 = 1.5kΩ**, **VCC = +5.0V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

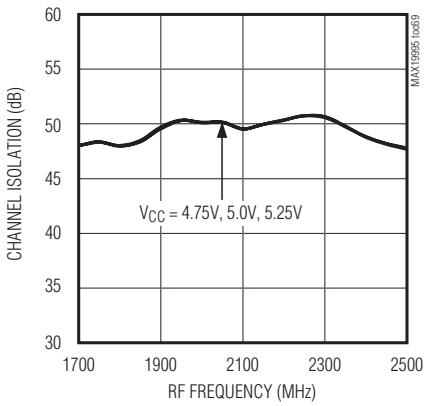
CHANNEL ISOLATION vs. RF FREQUENCY



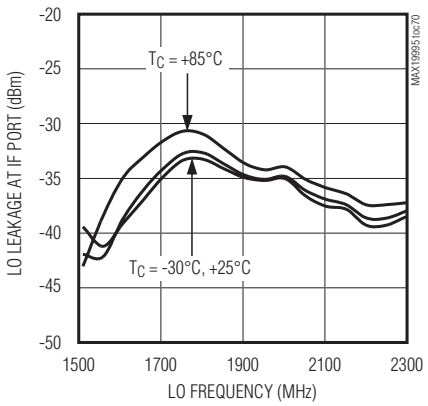
CHANNEL ISOLATION vs. RF FREQUENCY



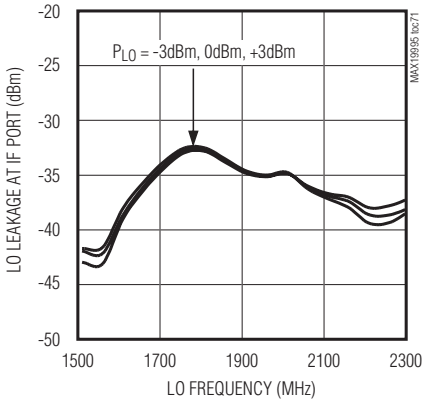
CHANNEL ISOLATION vs. RF FREQUENCY



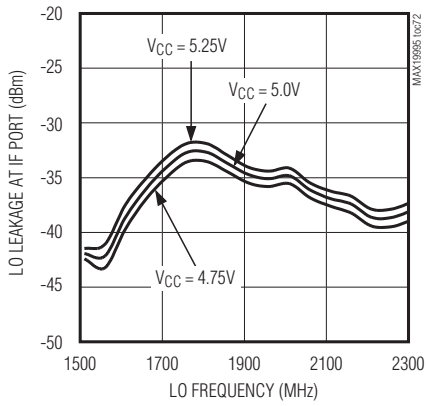
LO LEAKAGE AT IF PORT vs. LO FREQUENCY



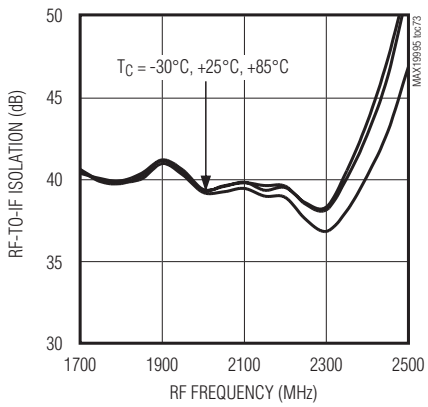
LO LEAKAGE AT IF PORT vs. LO FREQUENCY



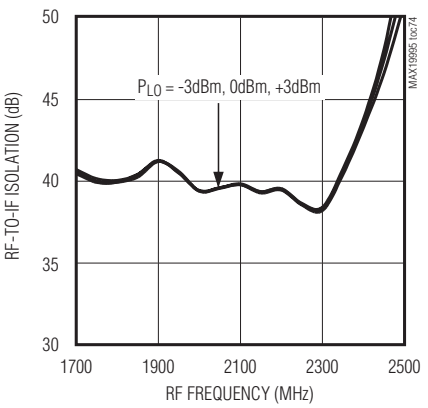
LO LEAKAGE AT IF PORT vs. LO FREQUENCY



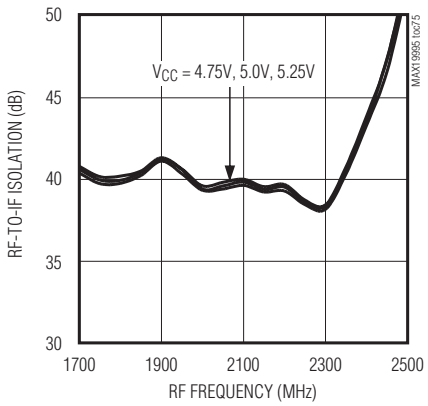
RF-TO-IF ISOLATION vs. RF FREQUENCY



RF-TO-IF ISOLATION vs. RF FREQUENCY



RF-TO-IF ISOLATION vs. RF FREQUENCY

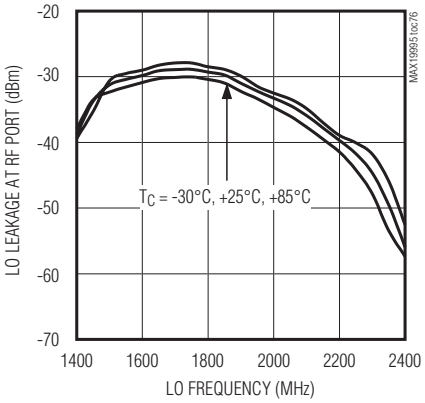


Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

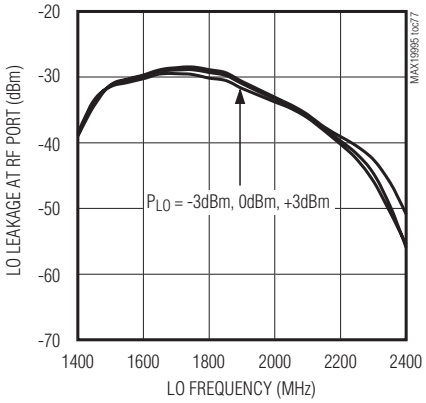
Typical Operating Characteristics (continued)

(*Typical Application Circuit*, optimized for the **UMTS band**, **R1 = R4 = 681Ω, R2 = R5 = 1.5kΩ**, **VCC = +5.0V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

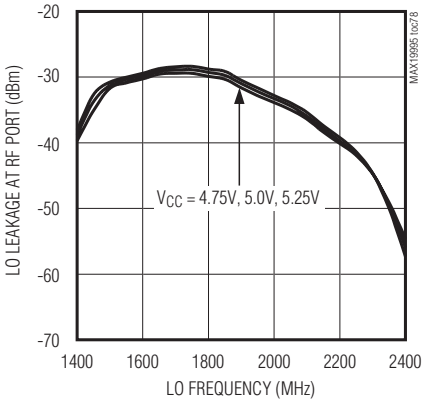
LO LEAKAGE AT RF PORT vs. LO FREQUENCY



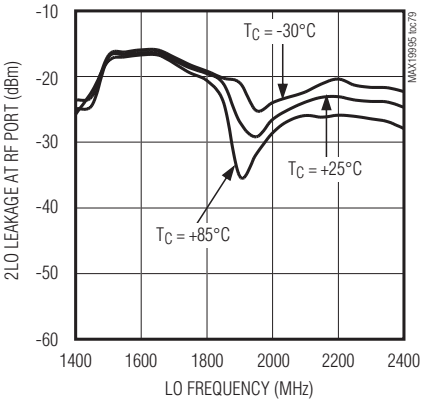
LO LEAKAGE AT RF PORT vs. LO FREQUENCY



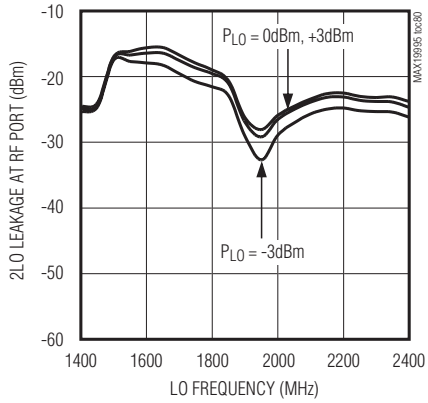
LO LEAKAGE AT RF PORT vs. LO FREQUENCY



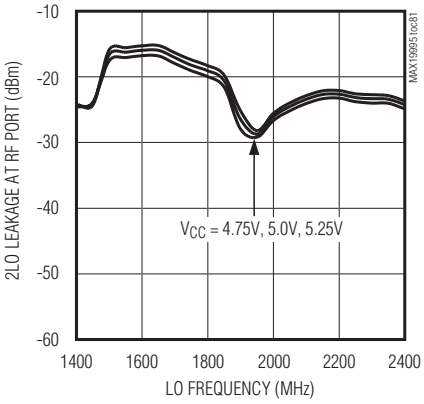
2LO LEAKAGE AT RF PORT vs. LO FREQUENCY



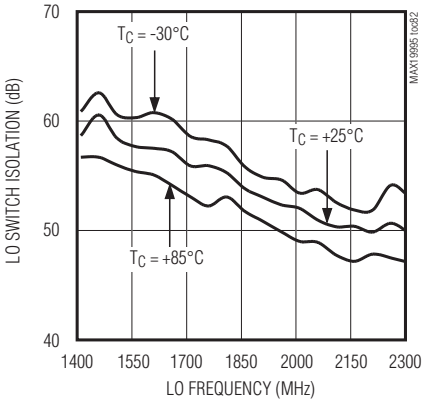
2LO LEAKAGE AT RF PORT vs. LO FREQUENCY



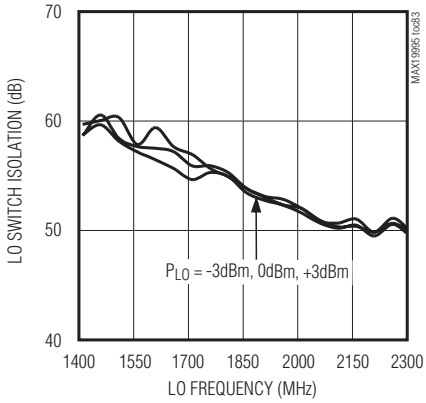
2LO LEAKAGE AT RF PORT vs. LO FREQUENCY



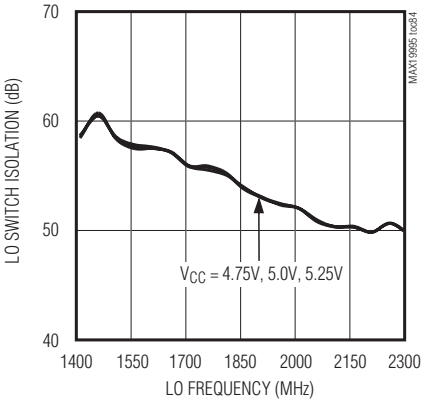
LO SWITCH ISOLATION vs. LO FREQUENCY



LO SWITCH ISOLATION vs. LO FREQUENCY



LO SWITCH ISOLATION vs. LO FREQUENCY

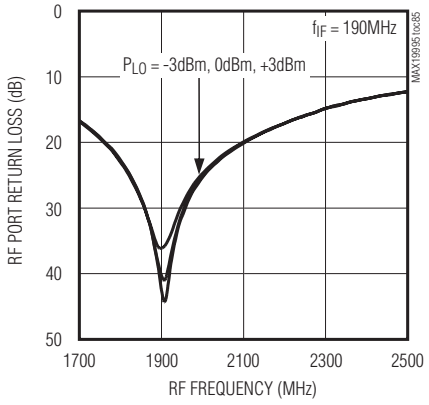


Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

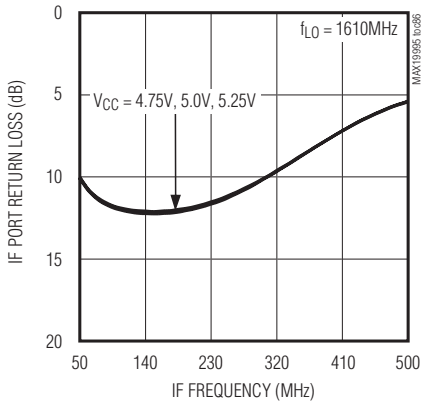
Typical Operating Characteristics (continued)

(*Typical Application Circuit*, optimized for the **UMTS band**, **R1 = R4 = 681Ω, R2 = R5 = 1.5kΩ**, **VCC = +5.0V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

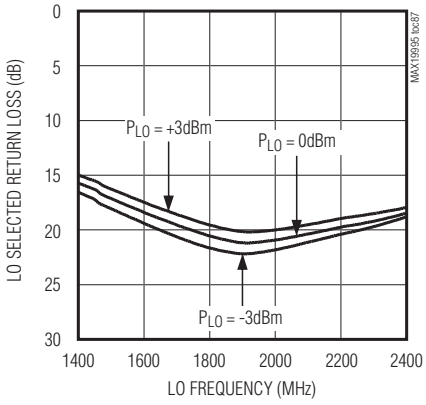
RF PORT RETURN LOSS vs. RF FREQUENCY



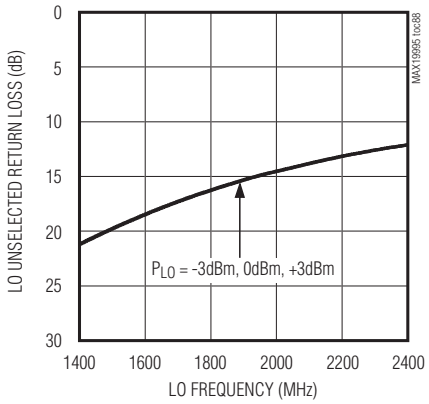
IF PORT RETURN LOSS vs. IF FREQUENCY



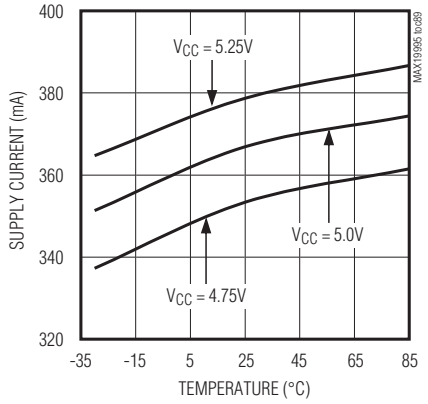
LO SELECTED RETURN LOSS vs. LO FREQUENCY



LO UNSELECTED RETURN LOSS vs. LO FREQUENCY



SUPPLY CURRENT vs. TEMPERATURE (T_C)

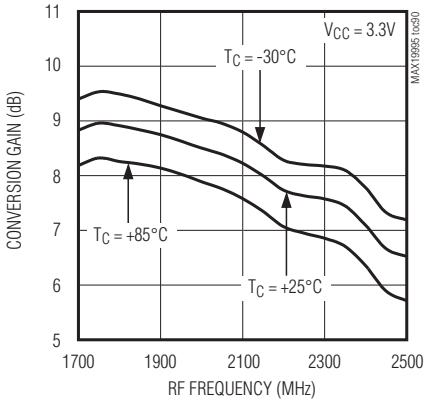


Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

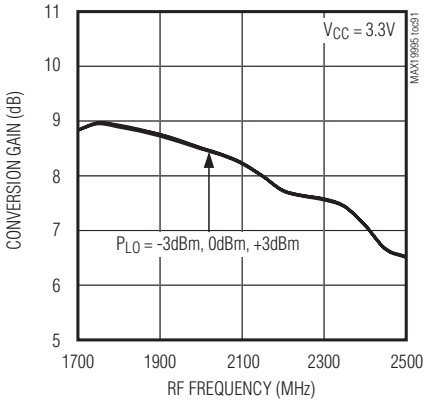
Typical Operating Characteristics (continued)

(*Typical Application Circuit*, **R1 = R4 = 909Ω**, **R2 = R5 = 2.49kΩ**, **VCC = +3.3V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

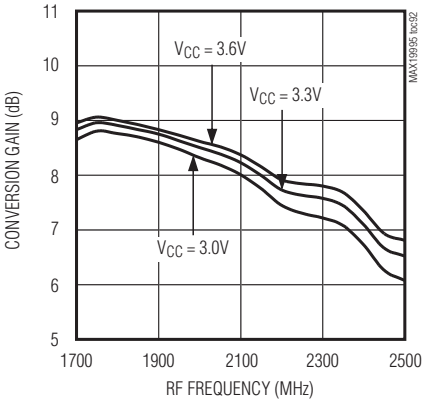
CONVERSION GAIN vs. RF FREQUENCY



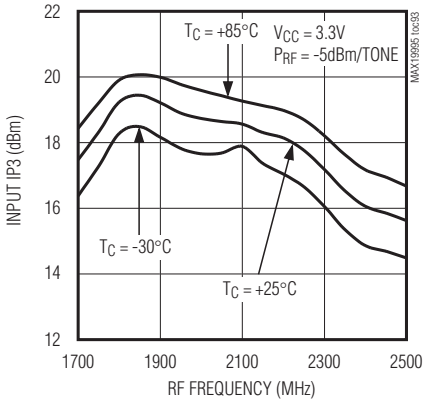
CONVERSION GAIN vs. RF FREQUENCY



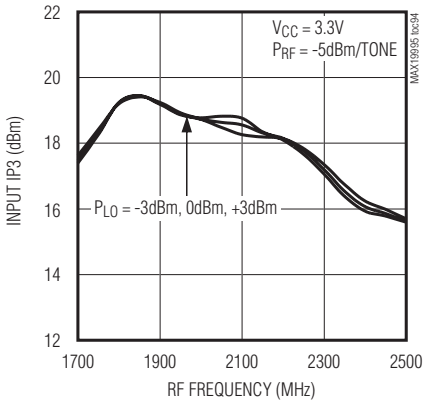
CONVERSION GAIN vs. RF FREQUENCY



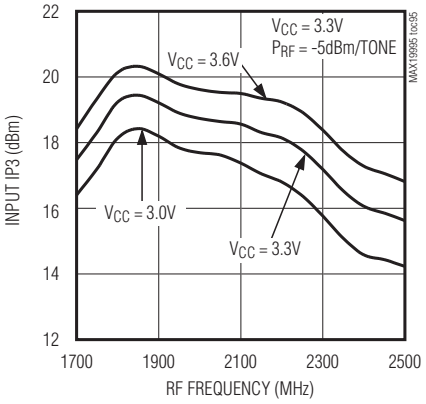
INPUT IP3 vs. RF FREQUENCY



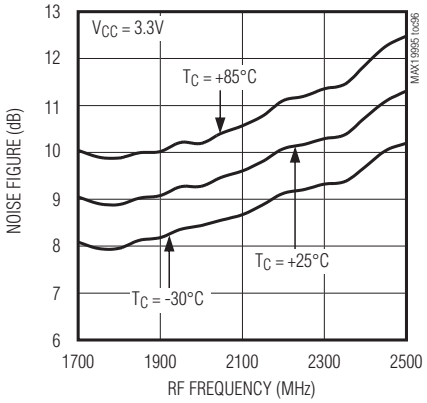
INPUT IP3 vs. RF FREQUENCY



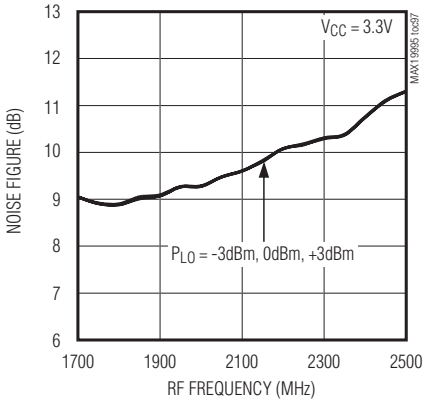
INPUT IP3 vs. RF FREQUENCY



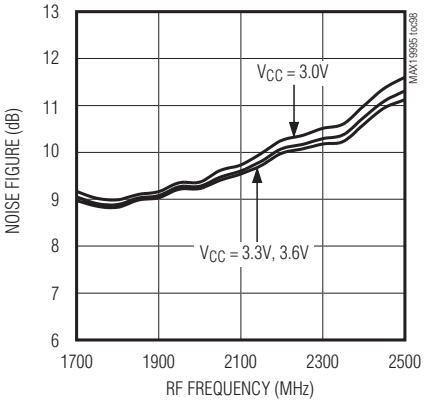
NOISE FIGURE vs. RF FREQUENCY



NOISE FIGURE vs. RF FREQUENCY



NOISE FIGURE vs. RF FREQUENCY

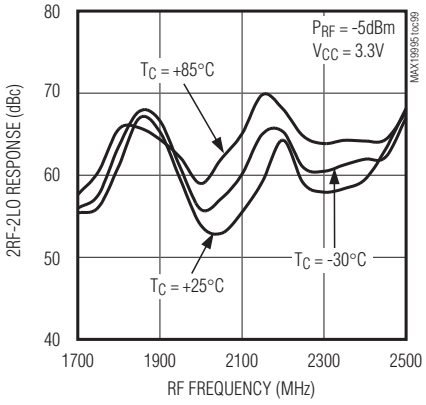


Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

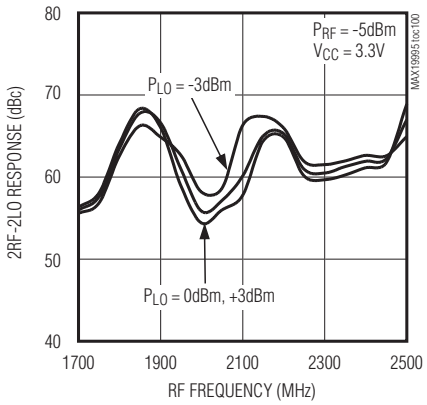
Typical Operating Characteristics (continued)

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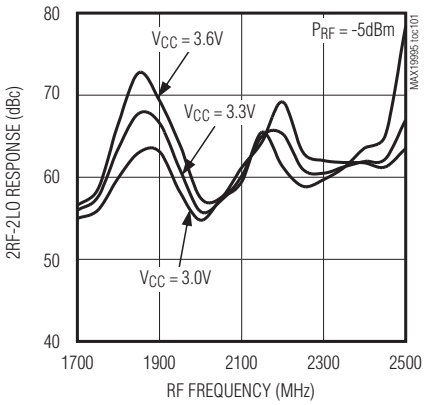
2RF-2LO RESPONSE vs. RF FREQUENCY



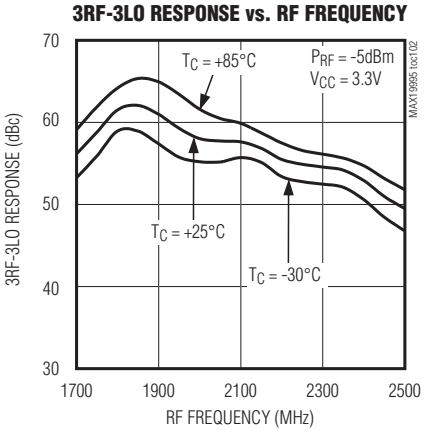
2RF-2LO RESPONSE vs. RF FREQUENCY



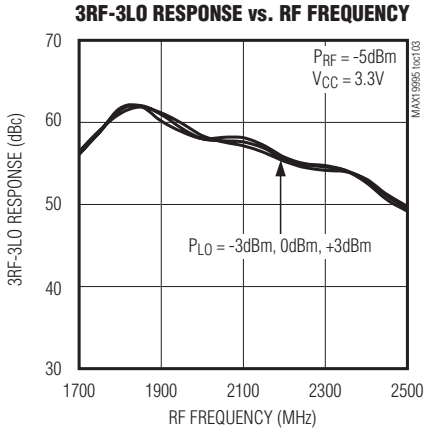
2RF-2LO RESPONSE vs. RF FREQUENCY



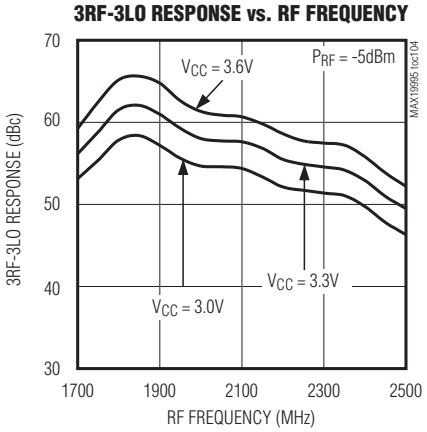
3RF-3LO RESPONSE vs. RF FREQUENCY



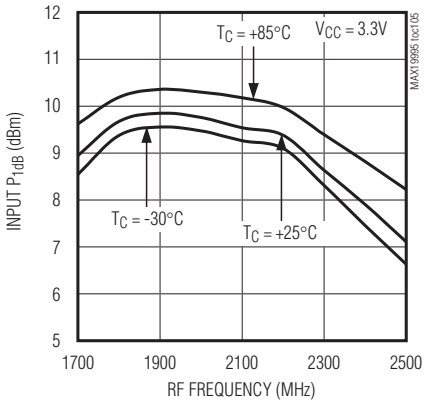
3RF-3LO RESPONSE vs. RF FREQUENCY



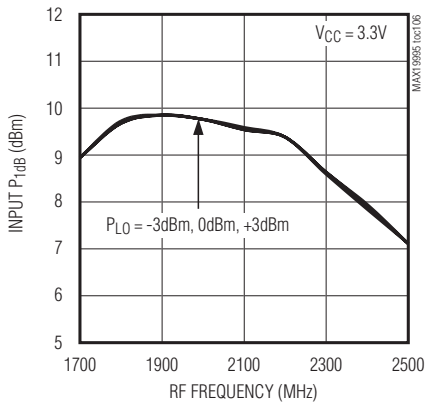
3RF-3LO RESPONSE vs. RF FREQUENCY



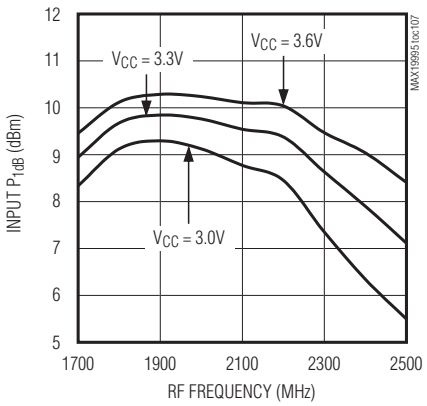
INPUT P_{1dB} vs. RF FREQUENCY



INPUT P_{1dB} vs. RF FREQUENCY



INPUT P_{1dB} vs. RF FREQUENCY

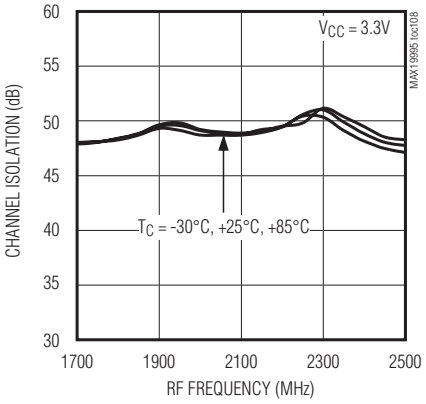


Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

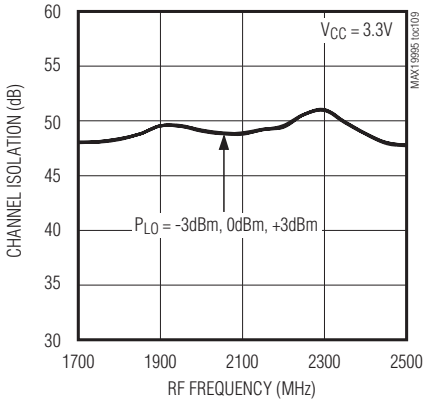
Typical Operating Characteristics (continued)

(*Typical Application Circuit*, **R1 = R4 = 909Ω**, **R2 = R5 = 2.49kΩ**, **V_{CC} = +3.3V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

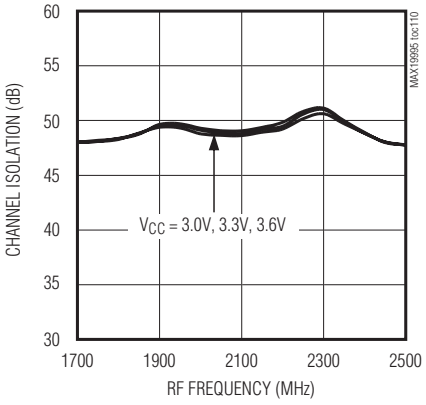
CHANNEL ISOLATION vs. RF FREQUENCY



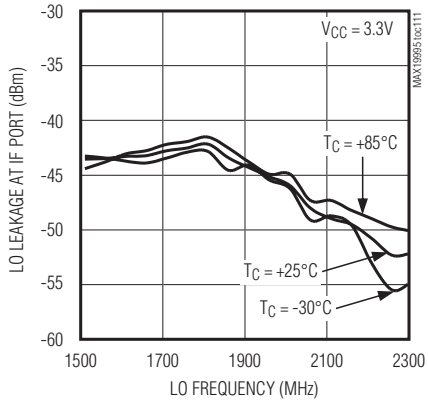
CHANNEL ISOLATION vs. RF FREQUENCY



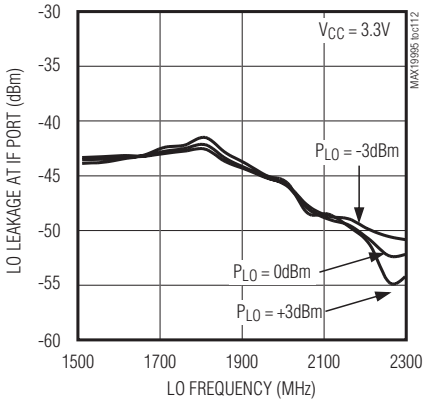
CHANNEL ISOLATION vs. RF FREQUENCY



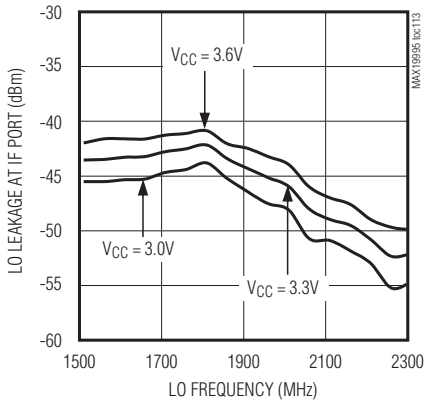
LO LEAKAGE AT IF PORT vs. LO FREQUENCY



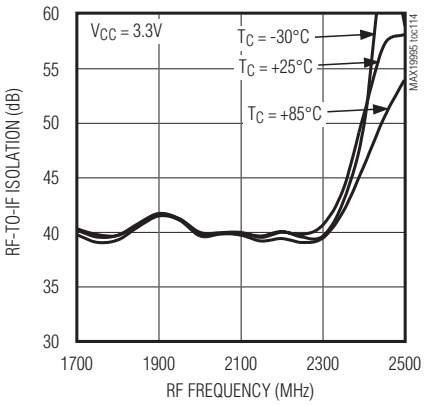
LO LEAKAGE AT IF PORT vs. LO FREQUENCY



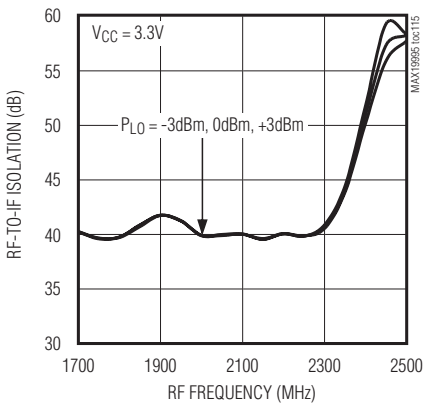
LO LEAKAGE AT IF PORT vs. LO FREQUENCY



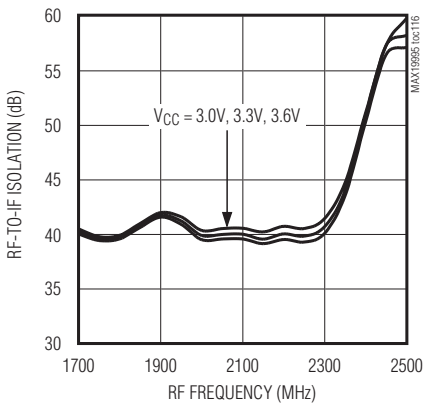
RF-TO-IF ISOLATION vs. RF FREQUENCY



RF-TO-IF ISOLATION vs. RF FREQUENCY



RF-TO-IF ISOLATION vs. RF FREQUENCY

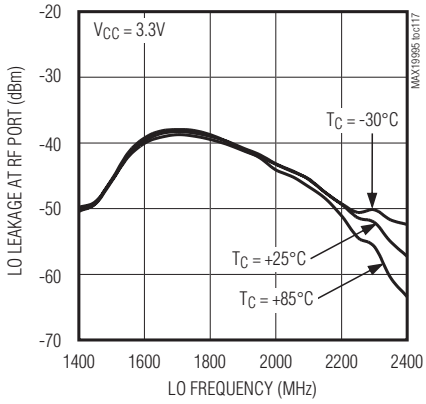


Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

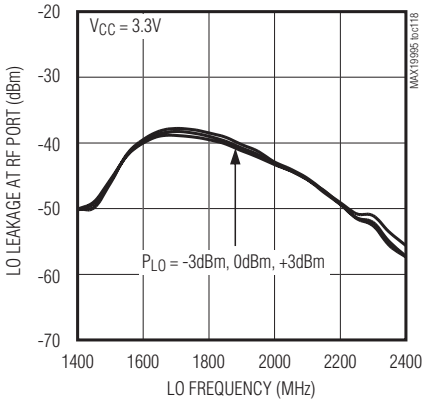
Typical Operating Characteristics (continued)

(*Typical Application Circuit*, **R1 = R4 = 909Ω**, **R2 = R5 = 2.49kΩ**, **V_{CC} = +3.3V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

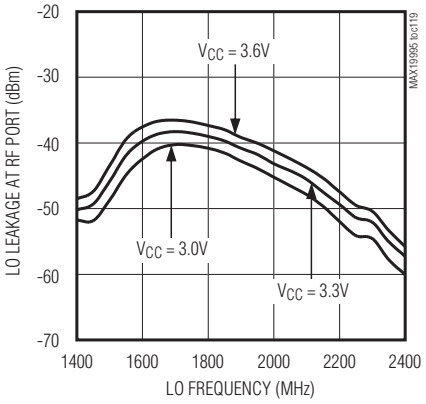
LO LEAKAGE AT RF PORT vs. LO FREQUENCY



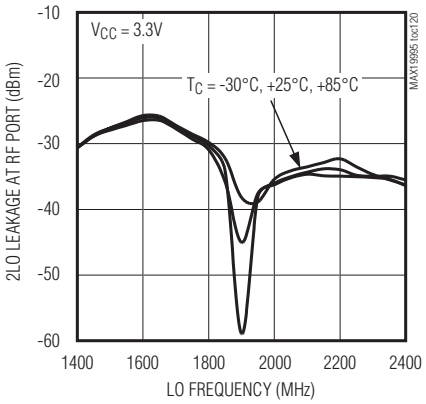
LO LEAKAGE AT RF PORT vs. LO FREQUENCY



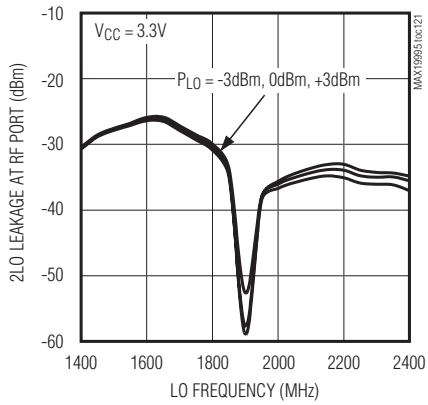
LO LEAKAGE AT RF PORT vs. LO FREQUENCY



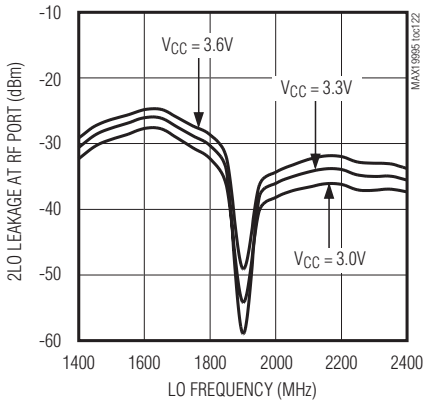
2LO LEAKAGE AT RF PORT vs. LO FREQUENCY



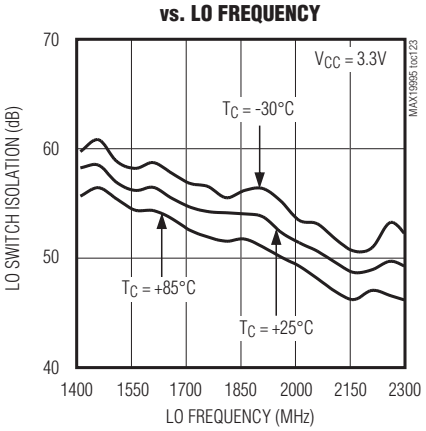
2LO LEAKAGE AT RF PORT vs. LO FREQUENCY



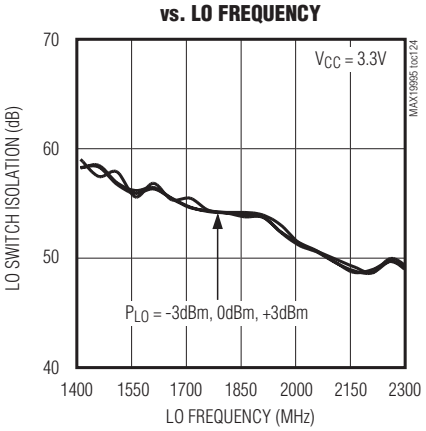
2LO LEAKAGE AT RF PORT vs. LO FREQUENCY



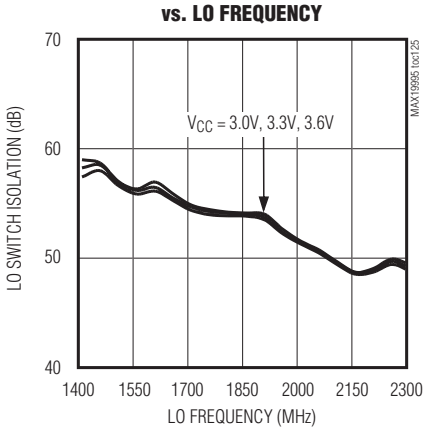
LO SWITCH ISOLATION vs. LO FREQUENCY



LO SWITCH ISOLATION vs. LO FREQUENCY



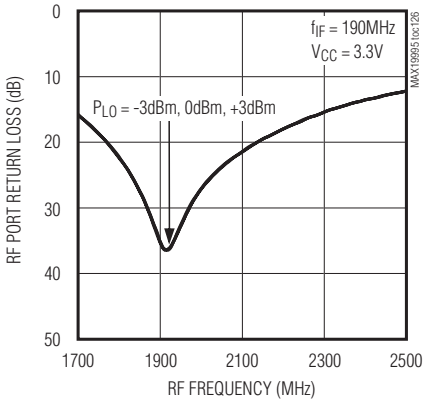
LO SWITCH ISOLATION vs. LO FREQUENCY



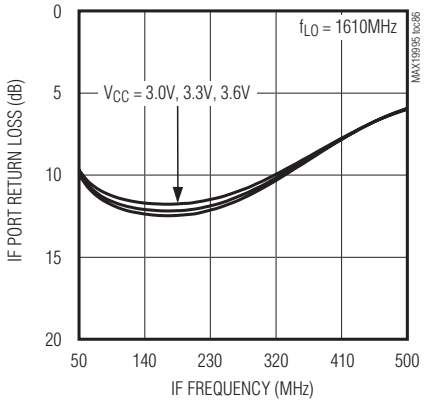
Typical Operating Characteristics (continued)

(*Typical Application Circuit*, **R1 = R4 = 909Ω**, **R2 = R5 = 2.49kΩ**, **V_{CC} = +3.3V**, P_{LO} = 0dBm, P_{RF} = -5dBm, LO is low-side injected for a 190MHz IF, T_C = +25°C, unless otherwise noted.)

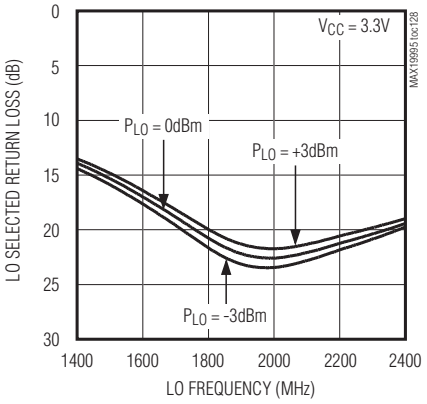
RF PORT RETURN LOSS vs. RF FREQUENCY



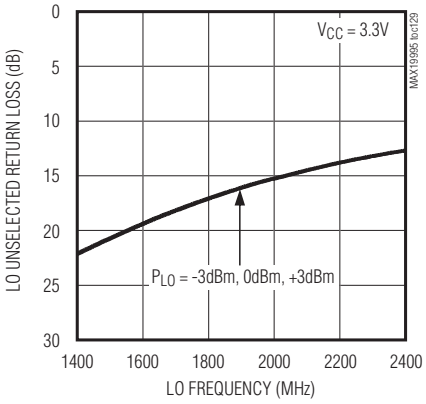
IF PORT RETURN LOSS vs. IF FREQUENCY



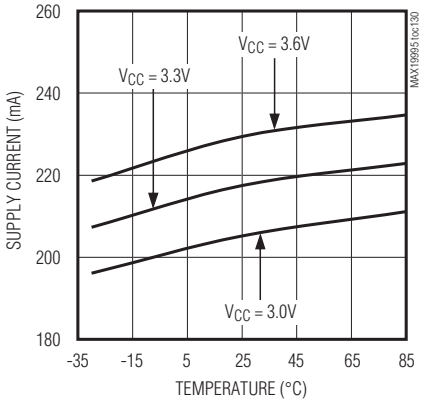
LO SELECTED RETURN LOSS vs. LO FREQUENCY



LO UNSELECTED RETURN LOSS vs. LO FREQUENCY



SUPPLY CURRENT vs. TEMPERATURE (T_C)



Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

Pin Description

PIN	NAME	FUNCTION
1	RFMAIN	Main Channel RF Input. Internally matched to 50Ω. Requires an input DC-blocking capacitor.
2	TAPMAIN	Main Channel Balun Center Tap. Bypass to GND with 39pF and 0.033µF capacitors as close as possible to the pin with the smaller value capacitor closer to the part.
3, 5, 7, 12, 20, 22, 24, 25, 26, 34	GND	Ground
4, 6, 10, 16, 21, 30, 36	V_{CC}	Power Supply. Bypass to GND with capacitors shown in the *Typical Application Circuit* as close as possible to the pin.
8	TAPDIV	Diversity Channel Balun Center Tap. Bypass to GND with 39pF and 0.033µF capacitors as close as possible to the pin with the smaller value capacitor closer to the part.
9	RFDIV	Diversity Channel RF Input. Internally matched to 50Ω. Requires an input DC-blocking capacitor.
11	IFD_SET	IF Diversity Amplifier Bias Control. Connect a resistor from this pin to ground to set the bias current for the diversity IF amplifier.
13, 14	IFD+, IFD-	Diversity Mixer Differential IF Output. Connect pullup inductors from each of these pins to V_{CC} (see the *Typical Application Circuit*).
15	IND_EXTD	Diversity External Inductor Connection. Connect this pin to ground. For improved RF-to-IF and LO-to-IF isolation, connect a low-ESR 10nH inductor from this pin to ground (see the *Typical Operating Characteristics* for typical performance vs. inductor value).
17	LO_ADJ_D	LO Diversity Amplifier Bias Control. Connect a resistor from this pin to ground to set the bias current for the diversity LO amplifier.
18, 28	N.C.	No Connection. Not internally connected.
19	LO1	Local Oscillator 1 Input. This input is internally matched to 50Ω. Requires an input DC-blocking capacitor.
23	LOSEL	Local Oscillator Select. Set this pin to high to select LO1. Set to low to select LO2.
27	LO2	Local Oscillator 2 Input. This input is internally matched to 50Ω. Requires an input DC-blocking capacitor.
29	LO_ADJ_M	LO Main Amplifier Bias Control. Connect a resistor from this pin to ground to set the bias current for the main LO amplifier.
31	IND_EXTM	Main External Inductor Connection. Connect this pin to ground. For improved RF-to-IF and LO-to-IF isolation, connect a low-ESR 10nH inductor from this pin to ground (see the *Typical Operating Characteristics* for typical performance vs. Inductor value).
32, 33	IFM-, IFM+	Main Mixer Differential IF Output. Connect pullup inductors from each of these pins to V_{CC} (see the *Typical Application Circuit*).
35	IFM_SET	IF Main Amplifier Bias Control. Connect a resistor from this pin to ground to set the bias current for the main IF amplifier.
—	EP	Exposed Pad. Internally connected to GND. Solder this exposed pad to a PCB pad that uses multiple ground vias to provide heat transfer out of the device into the PCB ground planes. These multiple via grounds are also required to achieve the noted RF performance.

Detailed Description

The MAX19995 is a dual-channel downconverter designed to provide 9dB of conversion gain, +24.8dBm input IP3, +13.3dBm 1dB input compression point, and a noise figure of 9dB.

In addition to its high-linearity performance, the MAX19995 achieves a high level of component integration. The device integrates two double-balanced mixers for two-channel downconversion. Both the main and diversity channels include a balun and matching circuitry to allow 50Ω single-ended interfaces to the RF ports and the two LO ports. An integrated single-pole, double-throw (SPDT) switch provides 50ns switching time between the two LO inputs, with 56dB of LO-to-LO isolation and -31dBm of LO leakage at the RF port. Furthermore, the integrated LO buffers provide a high drive level to each mixer core, reducing the LO drive required at the MAX19995's inputs to a range of -3dBm to +3dBm. The IF ports for both channels incorporate differential outputs for downconversion, which is ideal for providing enhanced 2RF-2LO performance.

Specifications are guaranteed over broad frequency ranges to allow for use in WCDMA/LTE, DCS1800/PCS1900 GSM/EDGE, and cdma2000 base stations. The MAX19995 is specified to operate over an RF input range of 1700MHz to 2200MHz, an LO range of 1400MHz to 2000MHz, and an IF range of 50MHz to 500MHz. The external IF components set the lower frequency range. Operation beyond these ranges is possible; see the *Typical Operating Characteristics* for additional information. Although this device is optimized for low-side LO injection applications, it can operate in high-side LO injection modes as well. However, performance degrades as f_{LO} continues to increase. For increased high-side LO performance, refer to the MAX19995A data sheet.

RF Port and Balun

The RF input ports of both the main and diversity channels are internally matched to 50Ω, requiring no external matching components. A DC-blocking capacitor is required as the input is internally DC shorted to ground through the on-chip balun. The RF port input return loss is typically better than 16dB over the RF frequency range of 1700MHz to 2200MHz.

LO Inputs, Buffer, and Balun

The MAX19995 is optimized for a 1400MHz to 2000MHz LO frequency range. As an added feature, the MAX19995 includes an internal LO SPDT switch for use in frequency-hopping applications. The switch selects one of the two single-ended LO ports, allowing the external oscillator to settle on a particular frequency before it is switched in. LO switching time is typically 50ns, which is more than adequate for typical GSM applications. If frequency hopping is not employed, simply set the switch to either of the LO inputs. The switch is controlled by a digital input (LOSEL), where logic-high selects LO1 and logic-low selects LO2. LO1 and LO2 inputs are internally matched to 50Ω, requiring only 39pF DC-blocking capacitors.

If LOSEL is connected directly to a logic source, then voltage **MUST** be applied to V_{CC} before digital logic is applied to LOSEL to avoid damaging the part. Alternatively, a 1kΩ resistor can be placed in series at the LOSEL to limit the input current in applications where LOSEL is applied before V_{CC}.

The main and diversity channels incorporate a two-stage LO buffer that allows for a wide-input power range for the LO drive. The on-chip low-loss baluns, along with LO buffers, drive the double-balanced mixers. All interfacing and matching components from the LO inputs to the IF outputs are integrated on chip.

High-Linearity Mixer

The core of the MAX19995 dual-channel downconverter consists of two double-balanced, high-performance passive mixers. Exceptional linearity is provided by the large LO swing from the on-chip LO buffers. When combined with the integrated IF amplifiers, the cascaded IIP3, 2RF-2LO rejection, and noise figure performance are typically +24.8dBm, 79dBc, and 9dB, respectively.

Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

Differential IF

The MAX19995 has an IF frequency range of 50MHz to 500MHz, where the low-end/high-end frequency depends on the frequency response of the external IF components. Note that these differential ports are ideal for providing enhanced IIP2 performance. Single-ended IF applications require a 4:1 (impedance ratio) balun to transform the 200Ω differential IF impedance to a 50Ω single-ended system. After the balun, the return loss is typically 12.5dB. The user can use a differential IF amplifier on the mixer IF ports, but a DC block is required on both IFD+/IFD- and IFM+/IFM- ports to keep external DC from entering the IF ports of the mixer.

Applications Information

Input and Output Matching

The RF and LO inputs are internally matched to 50Ω. No matching components are required. The RF port input return loss is typically better than 16dB over the RF frequency range of 1700MHz to 2200MHz and return loss at the LO ports are typically better than 16dB over the entire LO range. RF and LO inputs require only DC-blocking capacitors for interfacing.

The IF output impedance is 200Ω (differential). For evaluation, an external low-loss 4:1 (impedance ratio) balun transforms this impedance to a 50Ω single-ended output (see the *Typical Application Circuit*).

Reduced-Power Mode

Each channel of the MAX19995 has two pins (LO_ADJ_ _, IF_ _SET) that allow external resistors to set the internal bias currents. Nominal values for these resistors are given in Table 1. Larger value resistors can be used to reduce power dissipation at the expense of some performance loss. See the *Typical Operating Characteristics* to evaluate the biasing vs. performance tradeoff. If ±1% resistors are not readily available, ±5% resistors may be substituted.

Significant reductions in power consumption can also be realized by operating the mixer with an optional supply voltage of +3.3V. Doing so reduces the overall power consumption by up to 62%. See the *+3.3V Supply AC Electrical Characteristics* and the relevant +3.3V curves in the *Typical Operating Characteristics* section.

IND_EXT_ Inductors

For applications requiring optimum RF-to-IF and LO-to-IF isolation, connect low-ESR inductors from IND_EXT_ (pins 15 and 31) to ground. When improved isolation is not required, connect IND_EXT_ to ground using a 0Ω resistance. See the *Typical Operating Characteristics* to evaluate the isolation vs. inductor value tradeoff.

Layout Considerations

A properly designed PCB is an essential part of any RF/microwave circuit. Keep RF signal lines as short as possible to reduce losses, radiation, and inductance. The load impedance presented to the mixer must be such that any capacitance from both IF- and IF+ to ground does not exceed several picofarads. For the best performance, route the ground pin traces directly to the exposed pad under the package. The PCB exposed pad **MUST** be connected to the ground plane of the PCB. It is suggested that multiple vias be used to connect this pad to the lower-level ground planes. This method provides a good RF/thermal-conduction path for the device. Solder the exposed pad on the bottom of the device package to the PCB. The MAX19995 evaluation kit can be used as a reference for board layout. Gerber files are available upon request at **www.maxim-ic.com**.

Power-Supply Bypassing

Proper voltage-supply bypassing is essential for high-frequency circuit stability. Bypass each V_{CC} pin and TAPMAIN/TAPDIV with the capacitors shown in the *Typical Application Circuit* (see Table 1 for component values). Place the TAPMAIN/TAPDIV bypass capacitors to ground within 100 mils of the pin.

Exposed Pad RF/Thermal Considerations

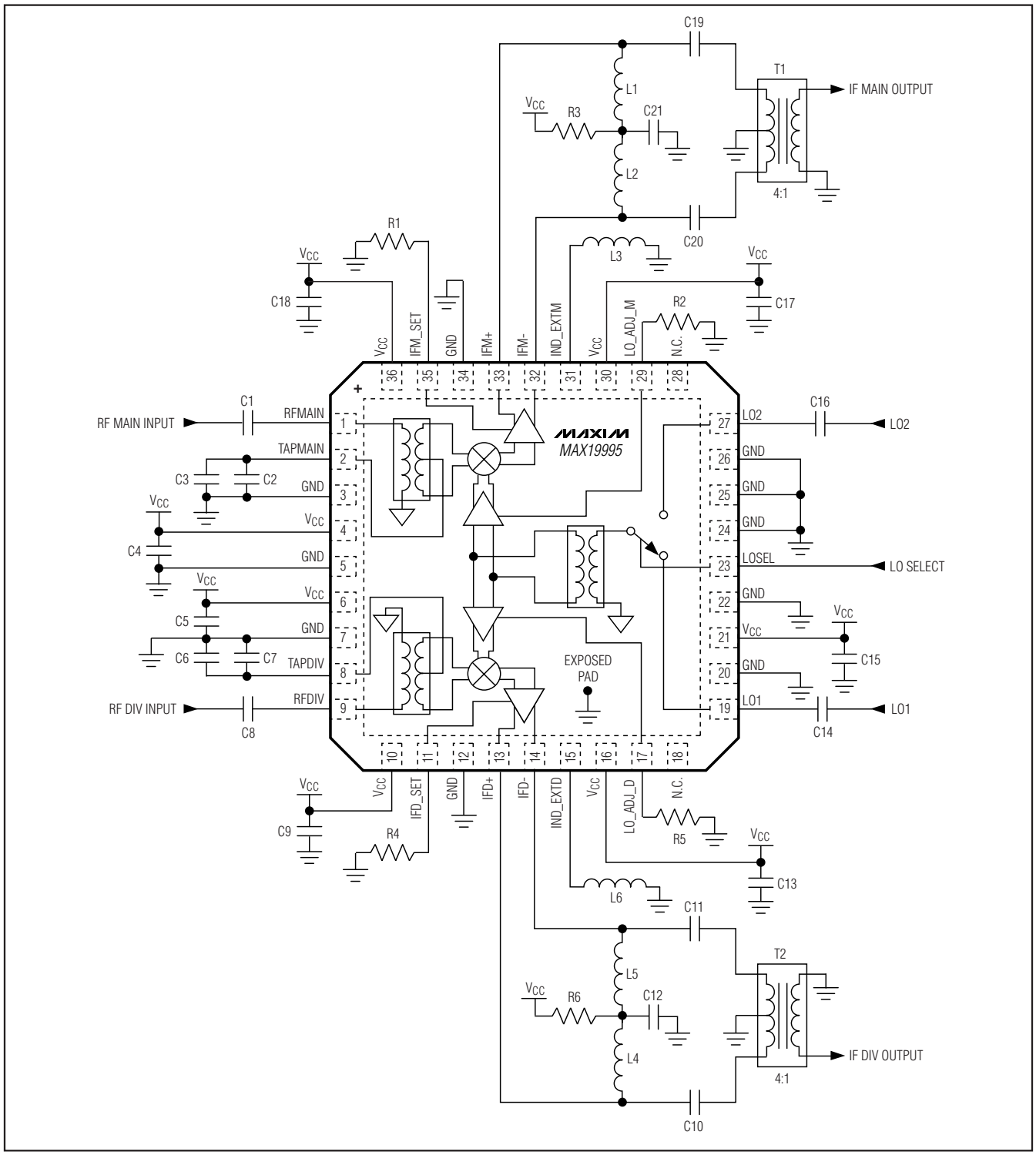
The exposed pad (EP) of the MAX19995's 36-pin thin QFN-EP package provides a low thermal-resistance path to the die. It is important that the PCB on which the MAX19995 is mounted be designed to conduct heat from the EP. In addition, provide the EP with a low-inductance path to electrical ground. The EP **MUST** be soldered to a ground plane on the PCB, either directly or through an array of plated via holes.

Table 1. Component Values

COMPONENT	VALUE	DESCRIPTION
C1, C2, C7, C8, C14, C16	39pF	Microwave capacitors (0402)
C3, C6	0.033µF	Microwave capacitors (0603)
C4, C5	—	Not used
C9, C13, C15, C17, C18	0.01µF	Microwave capacitors (0402)
C10, C11, C12, C19, C20, C21	150pF	Microwave capacitors (0603)
L1, L2, L4, L5	330nH	Wire-wound high-Q inductors (0805)
L3, L6	10nH	Wire-wound high-Q inductors (0603). Smaller values can be used at the expense of some performance loss (see the *Typical Operating Characteristics)*.
R1, R4	806Ω	±1% resistors (0402). Used for **DCS/PCS band, V_{CC} = +5.0V** applications. Larger values can be used to reduce power at the expense of some performance loss.
	681Ω	±1% resistors (0402). Used for **UMTS band, V_{CC} = +5.0V** applications. Larger values can be used to reduce power at the expense of some performance loss.
	909Ω	±1% resistors (0402). Used for **V_{CC} = +3.3V** applications.
R2, R5	2.32kΩ	±1% resistors (0402). Used for **DCS/PCS band, V_{CC} = +5.0V** applications. Larger values can be used to reduce power at the expense of some performance loss.
	1.5kΩ	±1% resistors (0402). Used for **UMTS band, V_{CC} = +5.0V** applications. Larger values can be used to reduce power at the expense of some performance loss.
	2.49kΩ	±1% resistors (0402). Used for **V_{CC} = +3.3V** applications.
R3, R6	0Ω	0Ω resistors (1206)
T1, T2	4:1	Transformers (200:50)
U1	—	MAX19995 IC

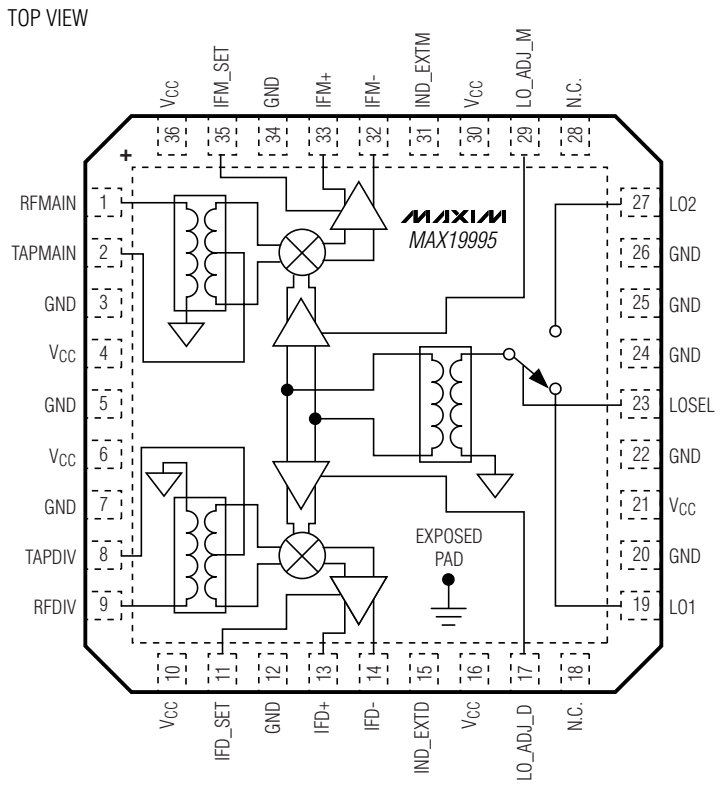
Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

Typical Application Circuit



Dual, SiGe, High-Linearity, 1700MHz to 2200MHz Downconversion Mixer with LO Buffer/Switch

Pin Configuration/Functional Diagram



THIN QFN (EXPOSED PAD)
6mm x 6mm

EXPOSED PAD ON THE BOTTOM OF THE PACKAGE

Chip Information

PROCESS: SiGe BiCMOS

Package Information

For the latest package outline information and land patterns, go to **www.maxim-ic.com/packages**.

PACKAGE TYPE	PACKAGE CODE	DOCUMENT NO.
36 Thin QFN-EP	T3666+2	21-0141

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